

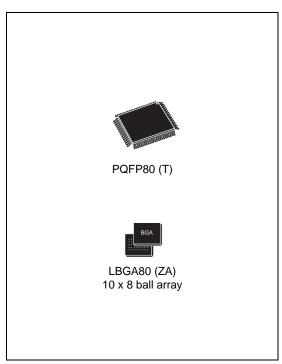
M58BW16F M58BW32F

16 or 32 Mbit (x32, Boot Block, Burst) 3.3V supply Flash memories

Preliminary Data

Features

- Supply voltage
 - V_{DD} = 2.7V to 3.6V (45ns) or V_{DD} = 2.5V to 3.3V (55ns)
 - V_{DDQ} = V_{DDQIN} = 2.4V to 3.6V for I/O Buffers
- High performance
 - Access times: 45 and 55ns
 - Synchronous Burst Reads
 - 75MHz Effective Zero Wait-State Burst Read
 - Asynchronous Page Reads
- M58BW32F memory organization:
 - Eight 64 Kbit small parameter blocks
 - Four 128 Kbit large parameter blocks
 - Sixty-two 512 Kbit main blocks
- M58BW16F memory organization:
 - Eight 64 Kbit parameter blocks
 - Thirty-one 512 Kbit main blocks
- Hardware block protection
 - WP pin to protect any block combination from Program and Erase operations
 - PEN signal for Program/Erase Enable
- Irreversible Modify protection (OTP like) on 128 Kbits:
 - Block 1 (bottom device) or Block 72 (top device) in the M58BW32F
 - Blocks 2 & 3 (bottom device) or Blocks 36 & 35 (top device) in the M58BW16F
- Security
 - 64-bit Unique Device Identifier (UID)
- Fast programming
 - Write to Buffer and Program capability
- Optimized for FDI drivers
 - Common Flash Interface (CFI)
 - Fast Program/Erase Suspend feature in each block



- Low power consumption
 - 100µA typical Standby current
- Electronic signature
 - Manufacturer Code: 0020h
 - Top Device Codes:
 M58BW32FT: 8838h
 M58BW16FT: 883Ah
 - Bottom Device Codes:
 M58BW32FB: 8837h
 M58BW16FB: 8839h
- Automotive Device Grade 3:
 - Temperature: –40 to 125°C
 - Automotive grade certified

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1 Description

The M58BW16F and M58BW32F are 16 and 32 Mbit non-volatile Flash memories, respectively. They can be erased electrically at block level and programmed in-system on a Double-Word basis using a 2.7V to 3.6V or 2.5V to 3.3V $V_{\rm DD}$ supply for the circuit and a 2.4V to 3.6V $V_{\rm DDO}$ supply voltage for the Input and Output buffers.

In the rest of the document the M58BW16F and M58BW32F will be referred to as M58BWxxF unless otherwise specified.

The devices support Asynchronous (Latch Controlled and Page Read) and Synchronous Bus operations. The Synchronous Burst Read Interface allows a high data transfer rate controlled by the Burst Clock signal, K. It is capable of bursting fixed or unlimited lengths of data. The burst type, latency and length are configurable and can be easily adapted to a large variety of system clock frequencies and microprocessors. All Write operations are Asynchronous. On power-up the memory defaults to Read mode with an Asynchronous Bus

The device features an asymmetrical block architecture:

- The M58BW32F has an array of 62 main blocks of 512 Kbits each, plus 4 large parameter blocks of 128Kbits each and 8 small parameter blocks of 64 Kbits each. The large and small parameter blocks are located either at the top (M58BW32FT) or at the bottom (M58BW32FB) of the address space. The first large parameter block is referred to as Boot Block and can be used either to store a boot code or parameters. The memory array organization is detailed in Table 2: M58BW32F top boot block addresses and Table 3: M58BW32F Bottom Boot Block Addresses.
- The M58BW16F has an array of 8 parameter blocks of 64Kb each and 31 main blocks of 512Kb each. In the M58BW16FT the parameter blocks are located at the top of the address space whereas in the M58BW16FB, they are located at the bottom. The memory array organization is detailed in Table 4: M58BW16F top boot block addresses and Table 5: M58BW16F bottom boot block addresses.

Program and Erase commands are written to the Command Interface of the memory. An onchip Program/Erase Controller simplifies the process of programming or erasing the memory by taking care of all of the special operations that are required to update the memory contents. The end of a Program or Erase operation can be detected and any error conditions identified in the Status Register. The command set required to control the memory is consistent with JEDEC standards.

Erase can be suspended in order to perform either Read or Program in any other block, and then resumed. Program can be suspended to Read data in any other block, and then resumed. Each block can be programmed and erased over 100,000 cycles.

All blocks are protected during power-up. The M58BWxxF features five different levels of hardware and software block protection to avoid unwanted program/erase operations:

- Write/Protect Enable input, WP, hardware protects a combination of blocks from program and erase operations. The blocks to be protected are configured individually by issuing a Set Block Protection Configuration Register or a Clear Block Protection Configuration Register command.
- All Program or Erase operations are blocked when Reset, RP, is held Low.
- A Program/Erase Enable input, PEN, is used to protect all blocks, preventing Program and Erase operations from affecting their data.
- A permanent user-enabled protection against Modify operations is available:
 - on one specific 128-Kbit parameter block in the M58BW32F Block 1 for bottom devices or Block 72 for top devices
 - on two specific 64-Kbit parameter blocks in the M58BW16F Blocks 2 & 3 for bottom devices or Blocks 36 & 35 for top devices.

A Reset/Power-down mode is entered when the \overline{RP} input is Low. In this mode the power consumption is reduced to the standby level, the device is write protected and both the Status and Burst Configuration Registers are cleared. A recovery time is required when the \overline{RP} input goes High.

A manufacturer code and a device code are available. They can be read from the memory allowing programming equipment or applications to automatically match their interface to the characteristics of the memory.

Finally, the M58BWxxF features a 64-bit Unique Device Identifier (UID) which is programmed by ST on the production line. It is unique for each die and can be used to implement cryptographic algorithms to improve security. Information is available in the CFI area (see *Table 30: M58BW16F extended guery information*).

The memory is offered in PQFP80 (14 x 20mm) and LBGA80 (1.0mm pitch) packages and it is supplied with all the bits erased (set to '1').

Figure 1. Logic diagram

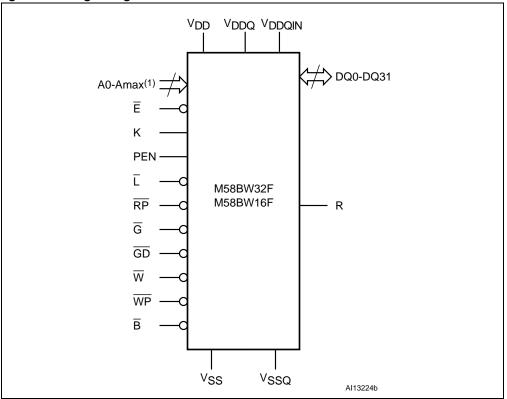


Table 1. Signal names

Address inputs	
Data Input/Output, Command Input	
Data Input/Output, Burst Configuration Register	
Data Input/Output	
Burst Address Advance input	
Chip Enable input	
Output Enable input	
Burst Clock input	
Latch Enable input	
Valid Data Ready output	
Reset /Power-Down input	
Write Enable input	
Output Disable input	
Write Protect input	
Supply Voltage	
Power Supply for Output Buffers	
Power Supply for Input Buffers only	
Program/Erase Enable	
Ground	
Input/Output Ground	
Not Connected Internally	
Don't Use as Internally Connected	

^{1.} Amax is equal to A18 in the M58BW16F, and to A19 in the M58BW32F.

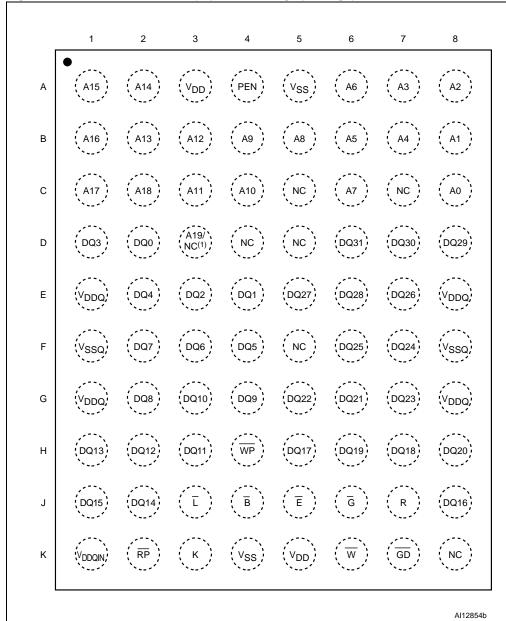


Figure 2. LBGA connections (top view through package)

1. Ball D3 is NC in the M58BW16F and A19 in the M58BW32F.

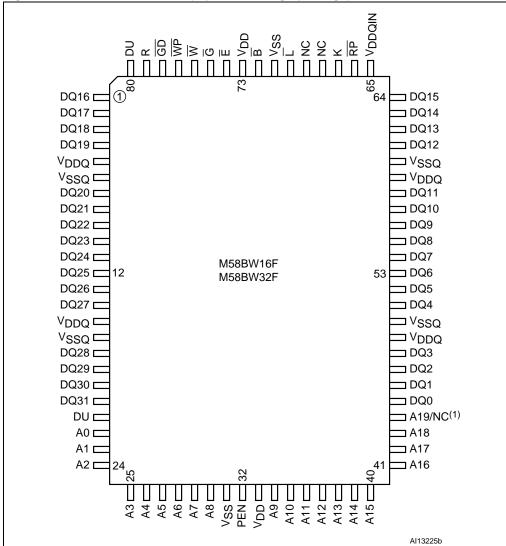


Figure 3. PQFP connections (top view through package)

1.1 Block Protection

The M58BWxxF features four different levels of block protection.

- Write Protect Pin, WP, When WP is Low, V_{IL}, the protection status that has been configured in the Block Protection Configuration Register is activated. The Block Protection Configuration Register is volatile. Any combination of blocks is possible. Any attempt to program or erase a protected block will return an error in the Status Register (see Table 13: Status Register Bits).
- Reset/Power-Down Pin, RP, If the device is held in reset mode (RP at V_{IL}), no program or erase operation can be performed on any block.
- Program/Erase Enable, PEN, The Program/Erase Enable input, PEN, protects all blocks by preventing Program and Erase operations from modifying the data.
 Prior to issuing a Program or Erase command, the Program/Erase Enable must be set to High (V_{IH}). If it is Low (V_{IL}), the Program or Erase operation is not accepted and an error is generated in the Status Register.
- **Permanent protection against Modify operations -** specific OTP-like blocks can be permanently protected against Modify operations (program/ erase):
 - in the M58BW32F, a unique 128-Kbit parameter block Block 1 (01000h-01FFFh) for bottom devices or Block 72 (FE000h-FEFFFh) for Top devices
 - in the M58BW16F, two 64-Kbit parameter blocks Blocks 2 & 3 (01000h-01FFFh) for bottom devices or Blocks 36 & 35 (7E000h-7EFFFh) for top devices

This protection is user-enabled. Details of how this protection is activated are provided in a dedicated application note.

After a device reset the first two kinds of block protection (\overline{WP} , \overline{RP}) can be combined to give a flexible block protection. All blocks are protected at power-up.

5//

Table 2. M58BW32F top boot block addresses

73 128 FF000h-FFFFh 72 128 FE000h-FEFFh(2) 71 128 FD000h-FDFFh 70 128 FC000h-FDFFh 69 64 FB800h-FBFFh 68 64 FB800h-FBFFh 67 64 FA800h-FAFFh 66 64 FA800h-FAFFh 65 64 F9800h-F9FFh 64 64 F9800h-F8FFh 62 64 F8800h-F8FFh 61 512 F4000h-F3FFh 60 512 F0000h-F3FFFh 60 512 F0000h-F3FFFh 59 512 EC000h-E7FFFh 58 512 E8000h-E3FFFh 56 512 E0000h-E3FFFh 56 512 E0000h-E3FFFh 55 512 DC000h-D7FFFh 54 512 D8000h-D8FFFh 55 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 52 512	#	Size (Kbit)	Address Range ⁽¹⁾
71 128 FD000h-FDFFFh 70 128 FC000h-FCFFFh 69 64 FB800h-FBFFFh 68 64 FB000h-FB7FFh 67 64 FA800h-FAFFFh 66 64 FA000h-FAFFFh 65 64 F9800h-F9FFh 64 64 F9800h-F9FFh 63 64 F8800h-F8FFh 61 512 F4000h-F7FFh 60 512 F0000h-F3FFh 60 512 F0000h-F3FFFh 59 512 E0000h-E7FFFh 58 512 E8000h-E8FFFh 56 512 E0000h-E3FFFh 56 512 E0000h-E3FFFh 55 512 DC000h-D7FFFh 54 512 D8000h-D8FFFh 53 512 D4000h-D7FFFh 54 512 D4000h-D7FFFh 55 512 D0000h-D3FFFh 51 512 C8000h-C7FFFh 49 512	73	128	FF000h-FFFFFh
70 128 FC000h-FCFFFh 69 64 FB800h-FBFFFh 68 64 FB800h-FBFFFh 67 64 FA800h-FAFFFh 66 64 FA800h-FAFFFh 65 64 F9800h-F9FFFh 63 64 F8800h-F8FFFh 62 64 F8000h-F8FFFh 61 512 F4000h-F7FFFh 60 512 F0000h-F3FFFh 59 512 EC000h-EFFFFh 58 512 E8000h-E8FFFh 57 512 E4000h-E7FFFh 56 512 E0000h-E8FFFh 55 512 DC000h-D8FFFh 54 512 D8000h-D8FFFh 53 512 D8000h-D8FFFh 53 512 D8000h-D8FFFh 53 512 D8000h-D8FFFh 53 512 C0000h-CFFFFh 54 512 C8000h-CFFFFh 50 512 C8000h-CFFFFh 49 512	72	128	FE000h-FEFFFh ⁽²⁾
69 64 FB800h-FBFFFh 68 64 FB000h-FBFFFh 67 64 FA800h-FAFFFh 66 64 FA000h-FAFFFh 65 64 FS900h-F9FFFh 65 64 FS900h-F9FFFh 66 64 FS900h-F9FFFh 67 65 64 FS900h-F9FFFh 68 65 64 FS900h-F8FFFh 69 60 FSSEPPPPPPPPPPPPPPPPPPPPPPPPPPPPPPPPPPP	71	128	FD000h-FDFFFh
68 64 FB000h-FB7FFh 67 64 FA800h-FAFFFh 66 64 FA000h-FA7FFh 65 64 F9800h-F97FFh 65 64 F9800h-F97FFh 66 64 F9800h-F87FFh 67 64 64 F8800h-F8FFFh 68 64 F8800h-F8FFFh 69 65 64 F8800h-F8FFFh 60 61 512 F4000h-F7FFFh 60 512 F0000h-F8FFFh 512 E0000h-E8FFFh 512 E0000h-E8FFFh 512 E0000h-E8FFFh 52 512 E0000h-E9FFFh 53 512 E0000h-DFFFFh 54 512 D0000h-DFFFFh 55 512 D0000h-DFFFFh 56 512 D0000h-DFFFFh 57 512 D0000h-DFFFFh 58 512 D0000h-DFFFFh 59 512 D0000h-DFFFFh 50 512 D0000h-DFFFFh 51 512 D0000h-DFFFFh 52 512 D0000h-DFFFFh 53 512 D0000h-DFFFFh 54 512 D0000h-DFFFFh 55 512 D0000h-DFFFFh 56 512 D0000h-DFFFFh 57 512 D0000h-DFFFFh 58 512 D0000h-DFFFFh 59 512 D0000h-DFFFFh 50 512 D0000h-DFFF	70	128	FC000h-FCFFFh
67 64 FA800h-FAFFFh 66 64 FA000h-FAFFFh 65 64 F9800h-F9FFFh 64 64 F9900h-F9FFFh 63 64 F8800h-F8FFFh 65 64 F8800h-F8FFFh 66 65 64 F8800h-F8FFFh 67 68 F8800h-F8FFFh 68 F8800h-F8FFFh 69 F12 F4000h-F3FFFh 59 F12 EC000h-EFFFFh 58 F12 E8000h-EFFFFh 58 F12 E9000h-EFFFFh 59 F12 E0000h-EFFFFh 50 F12 E0000h-EFFFFh 512 E0000h-EFFFFh 52 F12 E0000h-EFFFFh 53 F12 E0000h-DFFFFh 54 F12 D8000h-DFFFFh 55 F12 D0000h-DFFFFh 56 F12 E0000h-DFFFFh 57 F12 E0000h-DFFFFh 58 F12 E0000h-DFFFFh 59 F12 E0000h-DFFFFh 50 F12 E0000h-DFFFFh 51 F12 E0000h-DFFFFh 52 F12 E0000h-DFFFFh 53 F12 E0000h-DFFFFh 54 F12 E0000h-DFFFFh 55 F12 E0000h-DFFFFh 56 F12 E0000h-DFFFFh 57 F12 E0000h-DFFFFh 58 F12 E0000h-DFFFFh 59 F12 E0000h-DFFFFh 50 F12 E0000h-DFFFFh 51 F12 E0000h-DFFFFh 51 F12 E0000h-BFFFFh 52 F12 E0000h-BFFFFh 53 F12 E0000h-BFFFFh 54 F12 E0000h-BFFFFh 55 F12 E0000h-BFFFFh 56 F12 E0000h-BFFFFh 57 F12 E0000h-BFFFFh 58 F12 E0000h-BFFFFh F11 F12 E0000h-BFFFFh F12 E0000h-BFFFFh F13 F12 E0000h-BFFFFh F14 F15 E0000h-BFFFFh F15 F15 F15 E0000h-BFFFFh F16 F17 E0000h-BFFFFh F17 F18 E0000h-BFFFFh F18 E0000h-BFFFFh F19 E000	69	64	FB800h-FBFFFh
66 64 FA000h-FA7FFh 65 64 F9800h-F9FFFh 64 64 F9000h-F9FFFh 63 64 F8800h-F8FFFh 62 64 F8000h-F8FFFh 61 512 F4000h-F7FFFh 60 512 F0000h-F3FFFh 59 512 EC000h-EFFFFh 58 512 E8000h-EBFFFh 57 512 E4000h-E7FFFh 56 512 E0000h-B3FFFh 55 512 D8000h-DBFFFh 54 512 D8000h-DFFFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 C8000h-CFFFFh 49 512 C8000h-CFFFFh 49 512 C4000h-C7FFFh 48 512 C4000h-C7FFFh 46 512 B8000h-BFFFFh 45 512 B6000h-BFFFFh 44 512 B8000h-BFFFh 43 512 <td>68</td> <td>64</td> <td>FB000h-FB7FFh</td>	68	64	FB000h-FB7FFh
65 64 F9800h-F9FFFh 64 64 F9000h-F97FFh 63 64 F8800h-F8FFFh 62 64 F8000h-F87FFh 61 512 F4000h-F7FFh 60 512 F0000h-F3FFFh 59 512 EC000h-EFFFh 58 512 E8000h-EBFFFh 57 512 E4000h-E7FFFh 56 512 E0000h-E3FFFh 55 512 DC000h-DFFFFh 54 512 D8000h-DFFFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CFFFFh 49 512 C4000h-C7FFFh 48 512 C4000h-C3FFFh 46 512 B8000h-BFFFFh 45 512 B8000h-BFFFFh 45 512 B8000h-BFFFFh 45 512 B8000h-BFFFFh 45 512 <td>67</td> <td>64</td> <td>FA800h-FAFFFh</td>	67	64	FA800h-FAFFFh
64 64 F9000h-F97FFh 63 64 F8800h-F8FFFh 62 64 F8000h-F87FFh 61 512 F4000h-F7FFFh 60 512 F0000h-F3FFFh 59 512 EC000h-EFFFFh 58 512 E8000h-EBFFFh 57 512 E4000h-F7FFh 56 512 DC000h-DFFFFh 55 512 DC000h-DFFFFh 54 512 D8000h-DBFFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 42 512 A8000h-A8FFFh 41 512 </td <td>66</td> <td>64</td> <td>FA000h-FA7FFh</td>	66	64	FA000h-FA7FFh
63 64 F8800h-F8FFFh 62 64 F8000h-F87FFh 61 512 F4000h-F7FFFh 60 512 F0000h-F3FFFh 59 512 EC000h-EFFFFh 58 512 E8000h-EBFFFh 57 512 E4000h-E3FFFh 56 512 DC000h-DFFFFh 55 512 DC000h-DFFFFh 54 512 D8000h-DBFFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-B7FFFh 44 512 B4000h-A7FFFh 42 512 A8000h-A8FFFh 41 512 A4000h-A7FFFh 40 512	65	64	F9800h-F9FFFh
62 64 F8000h-F87FFh 61 512 F4000h-F7FFFh 60 512 F0000h-F3FFFh 59 512 EC000h-EFFFFh 58 512 E8000h-E8FFFh 57 512 E4000h-E7FFFh 56 512 E0000h-B7FFFh 55 512 DC000h-DFFFFh 54 512 D8000h-D8FFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-C8FFFh 49 512 C4000h-C7FFFh 48 512 C4000h-C7FFFh 48 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 41 512 A8000h-AFFFFh 40 512 A0000h-AFFFFh 40 51	64	64	F9000h-F97FFh
61 512 F4000h-F7FFFh 60 512 F0000h-F3FFFh 59 512 EC000h-EFFFFh 58 512 E8000h-EFFFFh 57 512 E4000h-E7FFFh 56 512 E0000h-DFFFFh 55 512 DC000h-DFFFFh 54 512 D8000h-DFFFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CFFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B7FFFh 43 512 A8000h-AFFFFh 41 512 A8000h-AFFFFh 40 512 A9000h-AFFFFh 40 512 A0000h-AFFFFh 39 5	63	64	F8800h-F8FFFh
60 512 F0000h-F3FFFh 59 512 EC000h-EFFFFh 58 512 E8000h-EBFFFh 57 512 E4000h-E7FFFh 56 512 E0000h-B3FFFh 55 512 DC000h-DFFFFh 54 512 D8000h-DBFFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 50 512 C8000h-CFFFFh 49 512 C4000h-CFFFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-BFFFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 41 512 A8000h-ABFFFh 41 512 A4000h-AFFFFh 40 512 A0000h-A9FFFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37	62	64	F8000h-F87FFh
59 512 EC000h-EFFFFh 58 512 E8000h-EBFFFh 57 512 E4000h-E7FFFh 56 512 E0000h-E3FFFh 55 512 DC000h-DFFFFh 54 512 D8000h-DBFFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BBFFFh 45 512 B4000h-BFFFFh 44 512 B0000h-BFFFFh 43 512 AC000h-AFFFFh 41 512 A8000h-AFFFFh 40 512 A0000h-AFFFFh 40 512 A0000h-AFFFFh 39 512 9000h-9FFFFh 38 512 94000h-9FFFFh	61	512	F4000h-F7FFFh
58 512 E8000h-E8FFFh 57 512 E4000h-E7FFFh 56 512 E0000h-B3FFFh 55 512 DC000h-DFFFFh 54 512 D8000h-D8FFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-BFFFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A9FFFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	60	512	F0000h-F3FFFh
57 512 E4000h-E7FFFh 56 512 E0000h-B3FFFh 55 512 DC000h-DFFFFh 54 512 D8000h-D8FFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-BFFFFh 44 512 B0000h-BFFFFh 43 512 AC000h-AFFFFh 42 512 A8000h-AFFFFh 41 512 A4000h-AFFFFh 40 512 A0000h-AFFFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	59	512	EC000h-EFFFFh
56 512 E0000h-E3FFFh 55 512 DC000h-DFFFFh 54 512 D8000h-D8FFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 41 512 A8000h-AFFFFh 40 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	58	512	E8000h-EBFFFh
55 512 DC000h-DFFFFh 54 512 D8000h-DBFFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 41 512 A8000h-AFFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	57	512	E4000h-E7FFFh
54 512 D8000h-DBFFFh 53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-AFFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	56	512	E0000h-E3FFFh
53 512 D4000h-D7FFFh 52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-C8FFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-AFFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	55	512	DC000h-DFFFFh
52 512 D0000h-D3FFFh 51 512 CC000h-CFFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-AFFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	54	512	D8000h-DBFFFh
51 512 CC000h-CFFFh 50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BBFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	53	512	D4000h-D7FFFh
50 512 C8000h-CBFFFh 49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BBFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	52	512	D0000h-D3FFFh
49 512 C4000h-C7FFFh 48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	51	512	CC000h-CFFFFh
48 512 C0000h-C3FFFh 47 512 BC000h-BFFFFh 46 512 B8000h-BBFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	50	512	C8000h-CBFFFh
47 512 BC000h-BFFFh 46 512 B8000h-BBFFFh 45 512 B4000h-B7FFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	49	512	C4000h-C7FFFh
46 512 B8000h-BBFFFh 45 512 B4000h-B7FFFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	48	512	C0000h-C3FFFh
45 512 B4000h-B7FFh 44 512 B0000h-B3FFFh 43 512 AC000h-AFFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	47	512	BC000h-BFFFFh
44 512 B0000h-B3FFfh 43 512 AC000h-AFFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	46	512	B8000h-BBFFFh
43 512 AC000h-AFFFh 42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	45	512	B4000h-B7FFFh
42 512 A8000h-ABFFFh 41 512 A4000h-A7FFFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	44	512	B0000h-B3FFFh
41 512 A4000h-A7FFh 40 512 A0000h-A3FFFh 39 512 9C000h-9FFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	43	512	AC000h-AFFFFh
40 512 A0000h-A3FFFh 39 512 9C000h-9FFFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	42	512	A8000h-ABFFFh
39 512 9C000h-9FFFh 38 512 98000h-9BFFFh 37 512 94000h-97FFFh	41	512	A4000h-A7FFFh
38 512 98000h-9BFFFh 37 512 94000h-97FFFh	40	512	A0000h-A3FFFh
37 512 94000h-97FFFh	39	512	9C000h-9FFFFh
	38	512	98000h-9BFFFh
36 512 90000h-93FFFh	37	512	94000h-97FFFh
	36	512	90000h-93FFFh

Table 2. M58BW32F top boot block addresses (continued)

#	Size (Kbit)	Address Range ⁽¹⁾
35	512	8C000h-8FFFFh
34	512	88000h-8BFFFh
33	512	84000h-87FFFh
32	512	80000h-83FFFh
31	512	7C000h-7FFFFh
30	512	78000h-7BFFFh
29	512	74000h-77FFFh
28	512	70000h-73FFFh
27	512	6C000h-6FFFFh
26	512	68000h-6BFFFh
25	512	64000h-67FFFh
24	512	60000h-63FFFh
23	512	5C000h-5FFFFh
22	512	58000h-5BFFFh
21	512	54000h-57FFFh
20	512	50000h-53FFFh
19	512	4C000h-4FFFFh
18	512	48000h-4BFFFh
17	512	44000h-47FFFh
16	512	40000h-43FFFh
15	512	3C000h-3FFFFh
14	512	38000h-3BFFFh
13	512	34000h-37FFFh
12	512	30000h-33FFFh
11	512	2C000h-2FFFFh
10	512	28000h-2BFFFh
9	512	24000h-27FFFh
8	512	20000h-23FFFh
7	512	1C000h-1FFFFh
6	512	18000h-1BFFFh
5	512	14000h-17FFFh
4	512	10000h-13FFFh
3	512	0C000h-0FFFFh
2	512	08000h-0BFFFh
1	512	04000h-07FFFh
0	512	00000h-03FFFh

^{1.} Addresses are indicated in 32-bit addressing.

^{2.} OTP Block.

Table 3. M58BW32F Bottom Boot Block Addresses

#	Size (Kbit)	Address Range ⁽¹⁾
73	512	FC000h-FFFFFh
72	512	F8000h-FBFFFh
71	512	F4000h-F7FFFh
70	512	F0000h-F3FFFh
69	512	EC000h-EFFFFh
68	512	E8000h-EBFFFh
67	512	E4000h-E7FFFh
66	512	E0000h-E3FFFh
65	512	DC000h-DFFFFh
64	512	D8000h-DBFFFh
63	512	D4000h-D7FFFh
62	512	D0000h-D3FFFh
61	512	CC000h-CFFFFh
60	512	C8000h-CBFFFh
59	512	C4000h-C7FFFh
58	512	C0000h-C3FFFh
57	512	BC000h-BFFFFh
56	512	B8000h-BBFFFh
55	512	B4000h-B7FFFh
54	512	B0000h-B3FFFh
53	512	AC000h-AFFFFh
52	512	A8000h-ABFFFh
51	512	A4000h-A7FFFh
50	512	A0000h-A3FFFh
49	512	9C000h-9FFFFh
48	512	98000h-9BFFFh
47	512	94000h-97FFFh
46	512	90000h-93FFFh
45	512	8C000h-8FFFFh
44	512	88000h-8BFFFh
43	512	84000h-87FFFh
42	512	80000h-83FFFh
41	512	7C000h-7FFFFh
40	512	78000h-7BFFFh
39	512	74000h-77FFFh
38	512	70000h-73FFFh
37	512	6C000h-6FFFFh
36	512	68000h-6BFFFh

Table 3. M58BW32F Bottom Boot Block Addresses (continued)

#	Size (Kbit)	Address Range ⁽¹⁾
35	512	64000h-67FFFh
34	512	60000h-63FFFh
33	512	5C000h-5FFFFh
32	512	58000h-5BFFFh
31	512	54000h-57FFFh
30	512	50000h-53FFFh
29	512	4C000h-4FFFFh
28	512	48000h-4BFFFh
27	512	44000h-47FFFh
26	512	40000h-43FFFh
25	512	3C000h-3FFFFh
24	512	38000h-3BFFFh
23	512	34000h-37FFFh
22	512	30000h-33FFFh
21	512	2C000h-2FFFFh
20	512	28000h-2BFFFh
19	512	24000h-27FFFh
18	512	20000h-23FFFh
17	512	1C000h-1FFFFh
16	512	18000h-1BFFFh
15	512	14000h-17FFFh
14	512	10000h-13FFFh
13	512	0C000h-0FFFFh
12	512	08000h-0BFFFh
11	64	07800h-07FFFh
10	64	07000h-077FFh
9	64	06800h-06FFFh
8	64	06000h-067FFh
7	64	05800h-05FFFh
6	64	05000h-057FFh
5	64	04800h-04FFFh
4	64	04000h-047FFh
3	128	03000h-03FFFh
2	128	02000h-02FFFh
1	128	01000h-01FFFh ⁽²⁾
0	128	00000h-00FFFh

^{1.} Addresses are indicated in 32-bit Word addressing.

^{2.} OTP Block.

Table 4. M58BW16F top boot block addresses

#	Size (Kbit)	Address Range
38	64	7F800h-7FFFFh
37	64	7F000h-7F7FFh
36 ⁽¹⁾	64	7E800h-7EFFFh
35 ⁽¹⁾	64	7E000h-7E7FFh
34	64	7D800h-7DFFFh
33	64	7D000h-7D7FFh
32	64	7C800h-7CFFFh
31	64	7C000h-7C7FFh
30	512	78000h-7BFFFh
29	512	74000h-77FFFh
28	512	70000h-73FFFh
27	512	6C000h-6FFFFh
26	512	68000h-6BFFFh
25	512	64000h-67FFFh
24	512	60000h-63FFFh
23	512	5C000h-5FFFFh
22	512	58000h-5BFFFh
21	512	54000h-57FFFh
20	512	50000h-53FFFh
19	512	4C000h-4FFFFh
18	512	48000h-4BFFFh
17	512	44000h-47FFFh
16	512	40000h-43FFFh
15	512	3C000h-3FFFFh
14	512	38000h-3BFFFh
13	512	34000h-37FFFh
12	512	30000h-33FFFh
11	512	2C000h-2FFFFh
10	512	28000h-2BFFFh
9	512	24000h-27FFFh
8	512	20000h-23FFFh
7	512	1C000h-1FFFFh
6	512	18000h-1BFFFh
5	512	14000h-17FFFh
4	512	10000h-13FFFh
3	512	0C000h-0FFFFh
2	512	08000h-0BFFFh
1	512	04000h-07FFFh
0	512	00000h-03FFFh

^{1.} OTP block.

Table 5. M58BW16F bottom boot block addresses

#	Size (Kbit)	Address Range
38	512	7C000h-7FFFFh
37	512	78000h-7BFFFh
36	512	74000h-77FFFh
35	512	70000h-73FFFh
34	512	6C000h-6FFFFh
33	512	68000h-6BFFFh
32	512	64000h-67FFFh
31	512	60000h-63FFFh
30	512	5C000h-5FFFFh
29	512	58000h-5BFFFh
28	512	54000h-57FFFh
27	512	50000h-53FFFh
26	512	4C000h-4FFFFh
25	512	48000h-4BFFFh
24	512	44000h-47FFFh
23	512	40000h-43FFFh
22	512	3C000h-3FFFFh
21	512	38000h-3BFFFh
20	512	34000h-37FFFh
19	512	30000h-33FFFh
18	512	2C000h-2FFFFh
17	512	28000h-2BFFFh
16	512	24000h-27FFFh
15	512	20000h-23FFFh
14	512	1C000h-1FFFFh
13	512	18000h-1BFFFh
12	512	14000h-17FFFh
11	512	10000h-13FFFh
10	512	0C000h-0FFFFh
9	512	08000h-0BFFFh
8	512	04000h-07FFFh
7	64	03800h-03FFFh
6	64	03000h-037FFh
5	64	02800h-02FFFh
4	64	02000h-027FFh
3 ⁽¹⁾	64	01800h-01FFFh
2 ⁽¹⁾	64	01000h-017FFh
1	64	00800h-00FFFh
0	64	00000h-007FFh

^{1.} OTP block.

2 Signal descriptions

See Figure 1: Logic diagram and Table 1: Signal names, for a brief overview of the signals connected to this device.

2.1 Address Inputs (A0-Amax)

Amax is equal to A18 in the M58BW16F, and to A19 in the M58BW32F.

The Address Inputs are used to select the cells to access in the memory array during Bus operations. During Bus Write operations they control the commands sent to the Command Interface of the Program/Erase Controller. Chip Enable must be Low when selecting the addresses.

The address inputs are latched on the rising edge of Latch Enable \overline{L} or Burst Clock K, whichever occurs first, in a read operation. The address inputs are latched on the rising edge of Chip Enable, Write Enable or Latch Enable, whichever occurs first in a Write operation. The address latch is transparent when Latch Enable is Low, V_{IL} . The address is internally latched in an Erase or Program operation.

2.2 Data Inputs/Outputs (DQ0-DQ31)

The Data Inputs/Outputs output the data stored at the selected address during a Bus Read operation, or are used to input the data during a program operation. During Bus Write operations they represent the commands sent to the Command Interface of the Program/Erase Controller. When used to input data or Write commands they are latched on the rising edge of Write Enable or Chip Enable, whichever occurs first.

When Chip Enable and Output Enable are both Low, V_{IL} , and Output Disable is at V_{IH} , the data bus outputs data from the memory array, the Electronic Signature, the Block Protection Configuration Register, the CFI Information or the contents of Burst Configuration Register or Status Register. The data bus is high impedance when the device is deselected with Chip Enable at V_{IH} , Output Enable at V_{IH} , Output Disable at V_{IL} or Reset/Power-Down at V_{IL} . The Status Register content is output on DQ0-DQ7 and DQ8-DQ31 are at V_{IL} .

2.3 Chip Enable (\overline{E})

The Chip Enable, \overline{E} , input activates the memory control logic, input buffers, decoders and sense amplifiers. Chip Enable, \overline{E} , at V_{IH} deselects the memory and reduces the power consumption to the Standby level.

2.4 Output Enable (G)

The Output Enable, \overline{G} , gates the outputs through the data output buffers during a read operation, when Output Disable \overline{GD} is at V_{IH} . When Output Enable \overline{G} is at V_{IH} , the outputs are high impedance independently of Output Disable.

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2.5 Output Disable (GD)

The Output Disable, \overline{GD} , deactivates the data output buffers. When Output Disable, \overline{GD} , is at V_{IH} , the outputs are driven by the Output Enable. When Output Disable, \overline{GD} , is at V_{IL} , the outputs are high impedance independently of Output Enable. The Output Disable pin must be connected to an external pull-up resistor as there is no internal pull-up resistor to drive the pin.

2.6 Write Enable (\overline{W})

The Write Enable, \overline{W} , input controls writing to the Command Interface, Input Address and Data latches. Both addresses and data can be latched on the rising edge of Write Enable (also see Latch Enable, \overline{L}).

2.7 Reset/Power-Down (RP)

The Reset/Power-Down, \overline{RP} , is used to apply a hardware reset to the memory. A hardware reset is achieved by holding Reset/Power-Down Low, V_{IL} , for at least t_{PLPH} . Writing is inhibited to protect data, the Command Interface and the Program/Erase Controller are reset. The Status Register information is cleared and power consumption is reduced to the standby level (I_{DD1}). The device acts as deselected, that is the data outputs are high impedance.

After Reset/Power-Down goes High, V_{IH} , the memory will be ready for Bus Read operations after a delay of t_{PHFI} or Bus Write operations after t_{PHWI} .

If Reset/Power-Down goes Low, V_{IL}, during a Block Erase or a Program operation, the operation is aborted, in a time of t_{PLRH} maximum, and data is altered and may be corrupted.

During Power-up power should be applied simultaneously to V_{DD} and $V_{\underline{DDQ(IN)}}$ with \overline{RP} held at V_{IL} . When the supplies are stable \overline{RP} is taken to V_{IH} . Output Enable, \overline{G} , Chip Enable, \overline{E} , and Write Enable, \overline{W} , should be held at V_{IH} during power-up.

In an application, it is recommended to associate the Reset/Power-Down pin, \overline{RP} , with the reset signal of the microprocessor. Otherwise, if a reset operation occurs while the memory is performing an erase or program operation, the memory may output the Status Register information instead of being initialized to the default Asynchronous Random Read mode.

See Table 22 and Figure 21: Reset, Power-Down and Power-up AC waveform, for more details.

2.8 Program/Erase Enable (PEN)

The Program/Erase Enable input, PEN, protects all blocks by preventing Program and Erase operations from modifying the data.

Prior to issuing a Program or Erase command, the Program/Erase Enable must be set to High (V_{IH}) . If it is Low (V_{IL}) , the Program or Erase operation is not accepted and an error is generated in the Status Register.

2.9 Latch Enable (L)

The Bus Interface can be configured to latch the Address Inputs on the rising edge of Latch Enable, \overline{L} , for Asynchronous Latch Enable Controlled Read or Write or Synchronous Burst Read operations. In Synchronous Burst Read operations the address is latched on the active edge of the Clock when Latch Enable is Low, V_{IL} . Once latched, the addresses may change without affecting the address used by the memory. When Latch Enable is Low, V_{IL} , the latch is transparent. Latch Enable, \overline{L} , can remain at V_{IL} for Asynchronous Random Read and Write operations.

2.10 Burst Clock (K)

The Burst Clock, K, is used to synchronize the memory with the external bus during Synchronous Burst Read operations. Bus signals are latched on the active edge of the Clock. In Synchronous Burst Read mode the address is latched on the first rising clock edge when Latch Enable is Low, V_{IL}, or on the rising edge of Latch Enable, whichever occurs first.

During Asynchronous bus operations the Clock is not used.

2.11 Burst Address Advance (B)

The Burst Address Advance, \overline{B} , controls the advancing of the address by the internal address counter during Synchronous Burst Read operations.

Burst Address Advance, \overline{B} , is only sampled on the active clock edge of the Clock when the X-latency time has expired. If Burst Address Advance is Low, V_{IL} , the internal address counter advances. If Burst Address Advance is High, V_{IH} , the internal address counter does not change; the same data remains on the Data Inputs/Outputs and Burst Address Advance is not sampled until the Y-latency expires.

The Burst Address Advance, \overline{B} , may be tied to V_{IL} .

2.12 Valid Data Ready (R)

The Valid Data Ready output, R, can be used during Synchronous Burst Read operations to identify if the memory is ready to output data or not. The Valid Data Ready output can be configured to be active on the clock edge of the invalid data read cycle or one cycle before. Valid Data Ready, at V_{IH} , indicates that new data is or will be available. When Valid Data Ready is Low, V_{IL} , the previous data outputs remain active.

2.13 Write Protect (WP)

The Write Protect, \overline{WP} , provides protection against program or erase operations. When Write Protect, \overline{WP} , is at V_{IL} , the protection status that has been configured in the Block Protection Configuration Register is activated. Program and erase operations to protected blocks are disabled. When Write Protect \overline{WP} is at V_{IH} all the blocks can be programmed or erased, if no other protection is used.

2.14 Supply Voltage (V_{DD})

The Supply Voltage, V_{DD} , is the core power supply. All internal circuits draw their current from the V_{DD} pin, including the Program/Erase Controller.

2.15 Output Supply Voltage (V_{DDQ})

The Output Supply Voltage, V_{DDQ}, is the output buffer power supply for all operations (Read, Program and Erase) used for DQ0-DQ31 when used as outputs.

2.16 Input Supply Voltage (V_{DDQIN})

The Input Supply Voltage, V_{DDIN} , is the power supply for all input signal. Input signals are: K, \overline{B} , \overline{L} , \overline{W} , \overline{GD} , \overline{G} , \overline{E} , A0-Amax and DQ0-DQ31, when used as inputs.

2.17 Ground (V_{SS} and V_{SSQ})

The Ground V_{SS} is the reference for the internal supply voltage V_{DD} . The Ground V_{SSQ} is the reference for the output and input supplies V_{DDQ} , and V_{DDQIN} . It is essential to connect V_{SS} and V_{SSQ} together.

Note:

A 0.1 μ F capacitor should be connected between the Supply Voltages, V_{DD} , V_{DDQ} and V_{DDIN} and the Grounds, V_{SS} and V_{SSQ} to decouple the current surges from the power supply. The PCB track widths must be sufficient to carry the currents required during all operations of the parts, see Table 17: DC characteristics, for maximum current supply requirements.

2.18 Don't Use (DU)

This pin should not be used as it is internally connected. Its voltage level can be between V_{SS} and V_{DDQ} or leave it unconnected.

2.19 Not Connected (NC)

This pin is not physically connected to the device.

3 Bus operations

Each bus operations that controls the memory is described in this section, see Tables 6 and 7 Bus Operations, for a summary. The bus operation is selected through the Burst Configuration Register; the bits in this register are described at the end of this section.

On Power-up or after a Hardware Reset the memory defaults to Asynchronous Bus Read and Asynchronous Bus Write. No synchronous operation can be performed until the Burst Control Register has been configured.

The Electronic Signature, Block Protection Configuration, CFI or Status Register will be read in asynchronous mode regardless of the Burst Control Register settings.

Typically glitches of less than 5ns on Chip Enable or Write Enable are ignored by the memory and do not affect bus operations.

3.1 Asynchronous Bus Operations

For asynchronous bus operations refer to *Table 6* together with the following text. The read access will start at whichever of the three following events occurs last: valid address transition, Chip Enable, \overline{E} , going Low, V_{II} or Latch Enable, \overline{L} , going Low, V_{II} .

3.1.1 Asynchronous Bus Read

Asynchronous Bus Read operations read from the memory cells, or specific registers (Electronic Signature, Block Protection Configuration Register, Status Register, CFI and Burst Configuration Register) in the Command Interface. A valid bus operation involves setting the desired address on the Address Inputs, applying a Low signal, $V_{\rm IL}$, to Chip Enable and Output Enable and keeping Write Enable and Output Disable High, $V_{\rm IH}$. The Data Inputs/Outputs will output the value, see *Figure 7: Asynchronous Bus Read AC waveforms*, and *Table 18: Asynchronous Bus Read AC characteristics*, for details of when the output becomes valid.

Asynchronous Read is the default read mode which the device enters on power-up or on return from Reset/Power-Down.

3.1.2 Asynchronous Latch Controlled Bus Read

Asynchronous Latch Controlled Bus Read operations read from the memory cells or specific registers in the Command Interface. The address is latched in the memory before the value is output on the data bus, allowing the address to change during the cycle without affecting the address that the memory uses.

A valid bus operation involves setting the desired address on the Address Inputs, setting Chip Enable and Latch Enable Low, V_{IL} and keeping Write Enable High, V_{IH} ; the address is latched on the rising edge of Latch Enable. Once latched, the Address Inputs can change. Set Output Enable Low, V_{IL} , to read the data on the Data Inputs/Outputs; see Figure Figure 8: Asynchronous Latch controlled bus Read AC waveforms and Table 18: Asynchronous Bus Read AC characteristics, for details on when the output becomes valid.

Note that, since the Latch Enable input is transparent when set Low, V_{IL} , Asynchronous Bus Read operations can be performed when the memory is configured for Asynchronous Latch Enable bus operations by holding Latch Enable Low, V_{IL} throughout the bus operation.

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3.1.3 Asynchronous Page Read

Asynchronous Page Read operations are used to read from several addresses within the same memory page. Each memory page is 4 Double-Words and is addressed by the address inputs A0 and A1.

Data is read internally and stored in the Page Buffer. Valid bus operations are the same as Asynchronous Bus Read operations but with different timings. The first read operation within the page has identical timings, subsequent reads within the same page have much shorter access times. If the page changes then the normal, longer timings apply again. Page Read does not support Latched Controlled Read.

See Figure 11: Asynchronous Page Read AC waveforms, and Table 19: Asynchronous Page Read AC characteristics, for details on when the outputs become valid.

3.1.4 Asynchronous Bus Write

Asynchronous Bus Write operations write to the Command Interface in order to send commands to the memory or to latch addresses and input data to program. Bus Write operations are asynchronous, the clock, K, is don't care during Bus Write operations.

A valid Asynchronous Bus Write operation begins by setting the desired address on the Address Inputs, and setting Chip Enable, Write Enable and Latch Enable Low, V_{IL} , and Output Enable High, V_{IH} , or Output Disable Low, V_{IL} . The Address Inputs are latched by the Command Interface on the rising edge of Chip Enable or Write Enable, whichever occurs first. Commands and Input Data are latched on the rising edge of Chip Enable, \overline{E} , or Write Enable, \overline{W} , whichever occurs first. Output Enable must remain High, and Output Disable Low, during the whole Asynchronous Bus Write operation.

See Figure 12: Asynchronous Write AC waveform, and Table 20: Asynchronous Write and Latch controlled Write AC characteristics, for details of the timing requirements.

3.1.5 Asynchronous Latch Controlled Bus Write

Asynchronous Latch Controlled Bus Write operations write to the Command Interface in order to send commands to the memory or to latch addresses and input data to program. Bus Write operations are asynchronous, the clock, K, is don't care during Bus Write operations.

A valid Asynchronous Latch Controlled Bus Write operation begins by setting the desired address on the Address Inputs and pulsing Latch Enable Low, V_{IL} . The Address Inputs are latched by the Command Interface on the rising edge of Latch Enable, Write Enable or Chip Enable, whichever occurs first. Commands and Input Data are latched on the rising edge of Chip Enable, \overline{E} , or Write Enable, \overline{W} , whichever occurs first. Output Enable must remain High, and Output Disable Low, during the whole Asynchronous Bus Write operation.

See Figure 13: Asynchronous Latch controlled Write AC waveform, and Table 20: Asynchronous Write and Latch controlled Write AC characteristics, for details of the timing requirements.

3.1.6 Output Disable

The data outputs are high impedance when the Output Enable, \overline{G} , is at V_{IH} or Output Disable, \overline{GD} , is at V_{IL} .

3.1.7 Standby

When Chip Enable is High, V_{IH} , and the Program/Erase Controller is idle, the memory enters Standby mode, the power consumption is reduced to the standby level (I_{DD1}) and the Data Inputs/Outputs pins are placed in the high impedance state regardless of Output Enable, Write Enable or Output Disable inputs.

The Standby mode can be disabled by setting the Standby Disable bit (M14) of the Burst Configuration Register to '1' (see *Table 17: DC characteristics*).

3.1.8 Reset/Power-Down

The memory is in Reset/Power-Down mode when Reset/Power-Down, \overline{RP} , is at V_{IL} . The power consumption is reduced to the standby level (I_{DD1}) and the outputs are high impedance, independent of the Chip Enable, \overline{E} , Output Enable, \overline{G} , Output Disable, \overline{GD} , or Write Enable, \overline{W} , inputs. In this mode the device is write protected and both the Status and the Burst Configuration Registers are cleared. A recovery time is required when the \overline{RP} input goes High.

Table 6. Asynchronous bus operations⁽¹⁾

Bus Operation	Step	Ē	G	GD	W	RP	Ī	A0-Amax	DQ0-DQ31
Asynchronous Bus Read ⁽²⁾		V_{IL}	V_{IL}	V _{IH}	V _{IH}	V _{IH}	V_{IL}	Address	Data Output
Asynchronous Latch Controlled Bus Read	Address Latch	V_{IL}	V _{IH}	V _{IH}	V_{IL}	V _{IH}	V_{IL}	Address	High Z
	Read	V_{IL}	V_{IL}	V _{IH}	V _{IH}	V _{IH}	V _{IH}	Х	Data Output
Asynchronous Page Read		V_{IL}	V_{IL}	V _{IH}	V _{IH}	V _{IH}	Х	Address	Data Output
Asynchronous Bus Write		V_{IL}	V _{IH}	Х	V _{IL}	V _{IH}	V _{IL}	Address	Data Input
Asynchronous Latch Controlled Bus Write	Address Latch	V_{IL}	V _{IH}	Х	V _{IH}	V _{IH}	V_{IL}	Address	High Z
	Write	V_{IL}	V _{IH}	Х	V_{IL}	V _{IH}	V_{IH}	X	Data Input
Output Enable, G		V_{IL}	V _{IH}	V _{IH}	V _{IH}	V _{IH}	Х	Х	High Z
Output Disable, GD		V_{IL}	V_{IL}	V_{IL}	V _{IH}	V _{IH}	Х	Х	High Z
Standby		V_{IH}	Х	Х	Х	V _{IH}	Х	Х	High Z
Reset/Power-Down		Х	Х	Х	Х	V _{IL}	Х	Х	High Z

^{1.} X = Don't Care.

Data, Manufacturer Code, Device Code, Burst Configuration Register, Standby Status and Block Protection Configuration Register are read using the Asynchronous Bus Read command.

3.2 Synchronous bus operations

For synchronous bus operations refer to *Table 7* together with the following text. The read access will start at whichever of the three following events occurs last: valid address transition, Chip Enable, \overline{E} , going Low, V_{II} or Latch Enable, \overline{L} , going Low, V_{II} .

3.2.1 Synchronous Burst Read

Synchronous Burst Read operations are used to read from the memory at specific times synchronized to an external reference clock. The valid edge of the Clock signal is the rising edge. Once the Flash memory is configured in Burst mode, it is mandatory to have an active clock signal since the switching of the output buffer databus is synchronized to the rising edge of the clock. In the absence of clock, no data is output.

The burst type, length and latency can be configured. The different configurations for Synchronous Burst Read operations are described in the Burst Configuration Register section. Refer to *Figure 4* for examples of synchronous burst operations.

A valid Synchronous Burst Read operation begins when the Burst Clock is active and Chip Enable and Latch Enable are Low, $V_{\rm IL}$. The burst start address is latched and loaded into the internal Burst Address Counter on the valid Burst Clock K edge or on the rising edge of Latch Enable, whichever occurs first.

After an initial memory latency time, the memory outputs data each clock cycle. The Burst Address Advance \overline{B} input controls the memory burst output. The second burst output is on the next clock valid edge after the Burst Address Advance \overline{B} has been pulled Low.

Valid Data Ready, R, monitors if the memory burst boundary is exceeded and the Burst Controller of the microprocessor needs to insert wait states. When Valid Data Ready is Low on the rising clock edge, no new data is available and the memory does not increment the internal address counter at the active clock edge even if Burst Address Advance, \overline{B} , is Low.

Valid Data Ready may be configured (by bit M8 of Burst Configuration Register) to be valid immediately at the rising clock edge.

Synchronous Burst Read will be suspended if Burst Address Advance, B, goes High, VIH.

If Output Enable is at V_{IL} and Output Disable is at V_{IH} , the last data is still valid.

If Output Enable, \overline{G} , is at V_{IH} or Output Disable, \overline{GD} , is at V_{IL} , but the Burst Address Advance, \overline{B} , is at V_{IL} the internal Burst Address Counter is incremented at each Burst Clock K rising edge.

The Synchronous Burst Read timing diagrams and AC Characteristics are described in the AC and DC Parameters section. See Figures 14, 17, 18 and 19, and Table 21.

3.2.2 Synchronous Burst Read Suspend

During a Synchronous Burst Read operation it is possible to suspend the operation, freeing the data bus for other higher priority devices.

A valid Synchronous Burst Read operation is suspended when both Output Enable and Burst Address Advance are High, V_{IH} . The Burst Address Advance going High, V_{IH} , stops the burst counter and the Output Enable going High, V_{IH} , inhibits the data outputs. The Synchronous Burst Read operation can be resumed by setting Output Enable Low.

Bus Operation	Step	Ē	G	GD	RP	К	Ē	B	A0-Amax DQ0-DQ31
Synchronous Burst Read ⁽²⁾	Address Latch	V_{IL}	V_{IH}	Х	V_{IH}	R ⁽³⁾	V_{IL}	Х	Address Input
	Read	V_{IL}	V_{IL}	V_{IH}	V_{IH}	R ⁽³⁾	V_{IH}	V_{IL}	Data Output
	Read Suspend	V _{IL}	V _{IH}	Х	V _{IH}	Х	V _{IH}	V _{IH}	High Z
	Read Resume	V _{IL}	V _{IL}	V _{IH}	V _{IH}	R ⁽³⁾	V _{IH}	V _{IL}	Data Output
	Burst Address Advance	V _{IL}	V _{IH}	Х	V _{IH}	R ⁽³⁾	V _{IH}	V _{IL}	High Z
	Read Abort, E	V_{IH}	Х	Х	V_{IH}	Х	Х	Х	High Z
	Read Abort, RP	Х	Х	Х	V_{IL}	Х	Х	Х	High Z

Table 7. Synchronous Burst Read bus operations

3.3 Burst Configuration Register

The Burst Configuration Register is used to configure the type of bus access that the memory will perform.

The Burst Configuration Register is set through the Command Interface and will retain its information until it is re-configured, the device is reset, or the device goes into Reset/Power-Down mode. The Burst Configuration Register bits are described in *Table 8*. They specify the selection of the burst length, burst type, burst X and Y latencies and the Read operation. Refer to *Figure 4* for examples of synchronous burst configurations.

3.3.1 Read Select Bit (M15)

The Read Select bit, M15, is used to switch between asynchronous and synchronous Bus Read operations. When the Read Select bit is set to '1', Bus Read operations are asynchronous; when the Read Select but is set to '0', Bus Read operations are synchronous.

On reset or power-up the Read Select bit is set to'1' for asynchronous accesses.

3.3.2 Standby Disable Bit (M14)

The Standby Disable Bit, M14, is used to disable the Standby mode. When the Standby bit is '1', the device will not enter Standby mode when Chip Enable goes High, V_{IH}.

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^{1.} $X = Don't Care, V_{IL} or V_{IH}$.

^{2.} M15 = 0, Bit M15 is in the Burst Configuration Register.

^{3.} R = Rising Edge.

3.3.3 X-Latency Bits (M13-M11)

The X-Latency bits are used during Synchronous Bus Read operations to set the number of clock cycles between the address being latched and the first data becoming available. For correct operation the X-Latency bits can only assume the values in *Table 8: Burst Configuration Register*.

3.3.4 Y-Latency Bit (M9)

The Y-Latency bit is used during Synchronous Bus Read operations to set the number of clock cycles between consecutive reads. The Y-Latency value depends on both the X-Latency value and the setting in M9.

When the Y-Latency is 1 the data changes each clock cycle.

3.3.5 Valid Data Ready Bit (M8)

The Valid Data Ready bit controls the timing of the Valid Data Ready output pin, R. When the Valid Data Ready bit is '0' the Valid Data Ready output pin is driven Low for the rising clock edge when invalid data is output on the bus.

3.3.6 Wrap Burst Bit (M3)

Burst read can be confined inside the 4 double-word boundary (wrap) or overcome the boundary (no wrap). When the wrap burst bit is set to '1' the burst read does not wrap. The wrap mode is not available (M3 is always '1').

3.3.7 Burst Length Bit (M2-M0)

The Burst Length bits set the maximum number of Double-Words that can be output during a Synchronous Burst Read operation. Burst lengths of 4 or 8 are available.

Table 8: Burst Configuration Register gives the valid combinations of the Burst Length bits that the memory accepts.

If a Burst Read operation (no wrap) has been initiated the device will output data synchronously. Depending on the starting address, the device activates the Valid Data Ready output to indicate that a delay is necessary before the data is output. If the starting address is aligned to a 4 double word boundary, the 8-double-word burst mode will run without activating the Valid Data Ready output. If the starting address is not aligned to a 4 Double Word boundary, Valid Data Ready is activated to indicate that the device needs an internal delay to read the successive words in the array.

M10, M7 to M4 are reserved for future use.

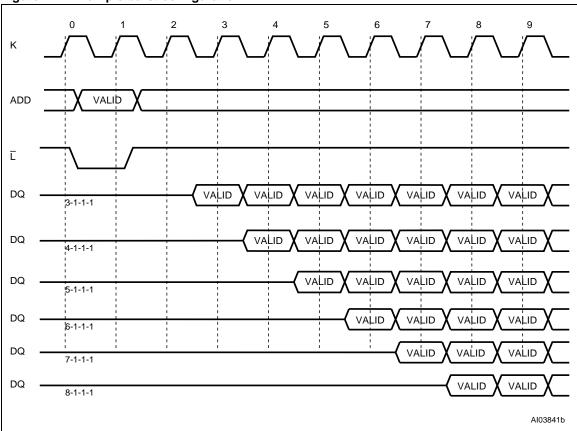
Table 8. Burst Configuration Register

Bit	Description	Value	Description			
M15	Read Select	0	Synchronous Burst Read			
		1	Asynchronous Read (Default at power-up)			
M14	Standby Disable	0	Standby Mode Enabled (Default at power-up)			
		1	Standby Mode Disabled			
M13-M11	X-Latency	001	3			
		010	4			
		011	5			
		100	6			
M10	Reserved					
M9	Y-Latency	0	Reserved			
IVIÐ		1	One Burst Clock cycle (M9 is always at '1')			
M8	Valid Data Ready	0	R valid Low during valid Burst Clock edge. (M8 is always at '0')			
		1	Reserved			
M7-M4	Reserved					
МЗ	Wrapping	0	Reserved			
		1	No Wrap (M3 is always at '1')			
M2-M0	Burst Length	001	4 Double-Words			
IVIZ-IVIU		010	8 Double-Words			

Table 9. Burst type definition

Start Address	×4 Sequential	×8 Sequential			
0	0-1-2-3	0-1-2-3-4-5-6-7			
1	1-2-3-4	1-2-3-4-5-6-7-8			
2	2-3-4-5	2-3-4-5-6-7-8-9			
3	3-4-5-6	3-4-5-6-7-8-9-10			
4	4-5-6-7	4-5-6-7-8-9-10-11			
5	5-6-7-8	5-6-7-8-9-10-11-12			
6	6-7-8-9	6-7-8-9-10-11-12-13			
7	7-8-9-10	7-8-9-10-11-12-13-14			
8	8-9-10-11	8-9-10-11-12-13-14-15			

Figure 4. Example burst configuration X-1-1-1



4 Command interface

All Bus Write operations to the memory are interpreted by the Command Interface. Commands consist of one or more sequential Bus Write operations. The Commands are summarized in *Table 10: Commands*. Refer to *Table 10* in conjunction with the text descriptions below.

4.1 Read Memory Array command

The Read Memory Array command returns the memory to Read mode. One Bus Write cycle is required to issue the Read Memory Array command and return the memory to Read mode. Subsequent read operations will output the addressed memory array data. Once the command is issued the memory remains in Read mode until another command is issued. From Read mode Bus Read commands will access the memory array.

4.2 Read Electronic Signature command

The Read Electronic Signature command is used to read the Manufacturer Code, the Device Code, the Block Protection Configuration Register and the Burst Configuration Register. One Bus Write cycle is required to issue the Read Electronic Signature command. Once the command is issued, subsequent Bus Read operations, depending on the address specified, read the Manufacturer Code, the Device Code, the Block Protection Configuration or the Burst Configuration Register until another command is issued; see *Table 11: Read Electronic Signature*.

4.3 Read Query command

The Read Query Command is used to read data from the Common Flash Interface (CFI) Memory Area. One Bus Write cycle is required to issue the Read Query Command. Once the command is issued subsequent Bus Read operations, depending on the address specified, read from the Common Flash Interface Memory Area.

4.4 Read Status Register command

The Read Status Register command is used to read the Status Register. One Bus Write cycle is required to issue the Read Status Register command. Once the command is issued subsequent Bus Read operations read the Status Register until another command is issued.

The Status Register information is present on the output data bus (DQ0-DQ7) when Chip Enable \overline{E} and Output Enable \overline{G} are at V_{II} and Output Disable is at V_{IH} .

An interactive update of the Status Register bits is possible by toggling Output Enable or Output Disable. It is also possible during a Program or Erase operation, by de-activating the device with Chip Enable at V_{IH} and then reactivating it with Chip Enable and Output Enable at V_{IL} and Output Disable at V_{IH} .

The content of the Status Register may also be read at the completion of a Program, Erase or Suspend operation. During a Block Erase or Program command, DQ7 indicates the Program/Erase Controller status. It is valid until the operation is completed or suspended.

See the section on the Status Register and *Table 13* for details on the definitions of the Status Register bits.

4.5 Clear Status Register command

The Clear Status Register command can be used to reset bits 1, 3, 4 and 5 in the Status Register to '0'. One Bus Write is required to issue the Clear Status Register command. Once the command is issued the memory returns to its previous mode, subsequent Bus Read operations continue to output the same data.

The bits in the Status Register are sticky and do not automatically return to '0' when a new Program, Erase, Block Protect or Block Unprotect command is issued. If any error occurs then it is essential to clear any error bits in the Status Register by issuing the Clear Status Register command before attempting a new Program, Erase or Resume command.

4.6 Block Erase command

The Block Erase command can be used to erase a block. It sets all of the bits in the block to '1'. All previous data in the block is lost. If the block is protected then the Erase operation will abort, the data in the block will not be changed and the Status Register will output the error.

Two Bus Write operations are required to issue the command; the first write cycle sets up the Block Erase command, the second write cycle confirms the Block erase command and latches the block address in the Program/Erase Controller and starts the Program/Erase Controller. The sequence is aborted if the Confirm command is not given and the device will output the Status Register Data with bits 4 and 5 set to '1'.

Once the command is issued subsequent Bus Read operations read the Status Register. See the section on the Status Register for details on the definitions of the Status Register bits. During the Erase operation the memory will only accept the Read Status Register command and the Program/Erase Suspend command. All other commands will be ignored.

If PEN is at V_{IH} , the operation can be performed. If PEN goes below V_{IH} , the operation aborts, the PEN Status bit in the Status Register is set to '1' and the command must be reissued.

Typical Erase times are given in *Table 12*. See *Appendix A*, *Figure 26*: *Block Erase flowchart and pseudo code*, for a suggested flowchart on using the Block Erase command.

4.7 Erase All Main Blocks command

The Erase All Main Blocks command is used to erase all 63 Main Blocks, without affecting the Parameter Blocks.

Issuing the Erase All Main Blocks command sets every bit in each Main Block to '1'. All data previously stored in the Main Blocks are lost.

Two Bus Write cycles are required to issue the Erase All Main Blocks command. The first cycle sets up the command, the second cycle confirms the command and starts the Program/Erase Controller. If the Confirm Command is not given the sequence is aborted, and Status Register bits 4 and 5 are set to '1'.

If the address given in the second cycle is located in a protected block, the Erase All Main Blocks operation aborts. The data remains unchanged in all blocks and the Status Register outputs the error.

Once the Erase All Main Blocks command has been issued, subsequent Bus Read operations output the Status Register. See the *Status Register* section for details.

During an Erase All Main Blocks operation, only the Read Status Register command is accepted by the memory; any other command are ignored. Erase All Main Blocks, once started, cannot be suspended.

If PEN is at V_{IH} , the operation will be performed. If PEN is lower than V_{IH} the operation aborts and the Status Register PEN bit (bit 3) is set to '1'.

4.8 Program command

The Program command is used to program the memory array. Two Bus Write operations are required to issue the command; the first write cycle sets up the Program command, the second write cycle latches the address and data to be programmed and starts the Program/Erase Controller. A program operation can be aborted by writing FFFFFFFh to any address after the program set-up command has been given.

The Program command is also used to program the OTP block. Refer to *Table 10: Commands*, for details of the address.

Once the command is issued subsequent Bus Read operations read the Status Register. See the section on the Status Register for details on the definitions of the Status Register bits. During the Program operation the memory will only accept the Read Status Register command and the Program/Erase Suspend command. All other commands will be ignored.

If Reset/Power-down, \overline{RP} , falls to V_{II} during programming the operation will be aborted.

If PEN is at V_{IH} , the operation can be performed. If PEN goes below V_{IH} , the operation aborts, the PEN Status bit in the Status Register is set to '1' and the command must be reissued.

See *Appendix A*, *Figure 24: Program flowchart and pseudo code*, for a suggested flowchart on using the Program command.

4.9 Write to Buffer and Program command

The Write to Buffer and Program Command makes use of the device's double Word (32 bit) Write Buffer to speed up programming.

Up to eight Double Words can be loaded into the Write Buffer and programmed into the memory.

Four successive steps are required to issue the command.

- One Bus Write operation is required to set up the Write to Buffer and Program Command. Any Bus Read operations will start to output the Status Register after the 1st cycle.
- Use one Bus Write operation to write the selected memory Block Address (any address in the block where the values will be programmed can be used) along with the value N on the Data Inputs/Outputs, where N+1 is the number of Words to be programmed. The maximum value of N+1 is 8 Words.
- Use N+1 Bus Write operations to load the address and data for each Word into the Write Buffer. The address must be between Start Address and Start Address plus N, where Start Address is the first word address.
- 4. Finally, use one Bus Write operation to issue the final cycle to confirm the command and start the Program operation.

If any address is outside the block boundaries or if the correct sequence is not followed, Status Register bits 4 and 5 are set to '1' and the operation will abort without affecting the data in the memory array. A protected block must be unprotected using the Blocks Unprotect command.

During a Write to Buffer and Program operation the memory will only accept the Read Status Register and the Program/Erase Suspend commands. All other commands are ignored. If PEN is at V_{IH} , the operation will be performed. If PEN is lower than V_{IH} the operation aborts and the Status Register PEN bit (bit 3) is set to '1'.

The Status Register should be cleared before re-issuing the command.

4.10 Program/Erase Suspend command

The Program/Erase Suspend command is used to pause a Program or Erase operation. The command will only be accepted during a Program or Erase operation. It can be issued at any time during a program or erase operation. The command is ignored if the device is already in suspend mode.

One Bus Write cycle is required to issue the Program/Erase Suspend command and pause the Program/Erase Controller. Once the command is issued it is necessary to poll the Program/Erase Controller Status bit (bit 7) to find out when the Program/Erase Controller has paused; no other commands will be accepted until the Program/Erase Controller has paused. After the Program/Erase Controller has paused, the memory will continue to output the Status Register until another command is issued.

During the polling period between issuing the Program/Erase Suspend command and the Program/Erase Controller pausing it is possible for the operation to complete. Once the Program/Erase Controller Status bit (bit 7) indicates that the Program/Erase Controller is no longer active, the Program Suspend Status bit (bit 2) or the Erase Suspend Status bit (bit 6) can be used to determine if the operation has completed or is suspended. For timing on the delay between issuing the Program/Erase Suspend command and the Program/Erase Controller pausing see *Note 12*.

During Program/Erase Suspend the Read Memory Array, Read Status Register, Read Electronic Signature, Read Query and Program/Erase Resume commands will be accepted by the Command Interface. Additionally, if the suspended operation was Erase then the Program, the Write to Buffer and Program, the Set/Clear Block Protection Configuration Register and the Program Suspend commands will also be accepted. When a program operation is completed inside a Block Erase Suspend the Read Memory Array command must be issued to reset the device in Read mode, then the Erase Resume command can be issued to complete the whole sequence. Only the blocks not being erased may be read or programmed correctly.

Erase operations can be suspended in a systematic and periodical way, however, in order to ensure the effectiveness of erase operations and avoid infinite erase times, it is imperative to wait a minimum time between successive Erase Resume and Erase Suspend commands. This time, called the Minimum effective erase time, is given in *Table 12 on page 39*.

See Appendix A, Figure 25: Program Suspend & Resume flowchart and pseudo code, and Figure 27: Erase Suspend & Resume flowchart and pseudo code, for suggested flowcharts on using the Program/Erase Suspend command.

4.11 Program/Erase Resume command

The Program/Erase Resume command can be used to restart the Program/Erase Controller after a Program/Erase Suspend operation has paused it. One Bus Write cycle is required to issue the Program/Erase Resume command.

See Appendix A, Figure 25: Program Suspend & Resume flowchart and pseudo code, and Figure 27: Erase Suspend & Resume flowchart and pseudo code, for suggested flowcharts on using the Program/Erase Suspend command.

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4.12 Set Burst Configuration Register command

The Set Burst Configuration Register command is used to write a new value to the Burst Configuration Register which defines the burst length, type, X and Y latencies, Synchronous/Asynchronous Read mode.

Two Bus Write cycles are required to issue the Set Burst Configuration Register command. The first cycle writes the setup command. The second cycle writes the address where the new Burst Configuration Register content is to be written, and confirms the command. If the command is not confirmed, the sequence is aborted and the device outputs the Status Register with bits 4 and 5 set to '1'. Once the command is issued the memory returns to Read mode as if a Read Memory Array command had been issued.

The value for the Burst Configuration Register is always presented on A0-A15. M0 is on A0, M1 on A1, etc.; the other address bits are ignored.

4.13 Set Block Protection Configuration Register command

The Set Block Protection Configuration Register command is used to configure the Block Protection Configuration Register to 'Protected', for a specific block. Protected blocks are fully protected from program or erase when \overline{WP} pin is Low, V_{IL} . The status of a protected block can be changed to 'Unprotected' by using the Clear Block Protection Configuration Register command. At power-up, all block are configured as 'Protected'.

Two bus operations are required to issue a Set Block Protection Configuration Register command:

- The first cycle writes the setup command
- The second write cycle specifies the address of the block to protect and confirms the command. If the command is not confirmed, the sequence is aborted and the device outputs the Status Register with bits 4 and 5 set to '1'.

To protect multiple blocks, the Set Block Protection Configuration Register command must be repeated for each block.

Any attempt to re-protect a block already protected does not change its status.

4.14 Clear Block Protection Configuration Register command

The Clear Block Protection Configuration Register command is used to configure the Block Protection Configuration Register to 'Unprotected', for a specific block thus allowing program/erase operations to this block, regardless of the WP pin status.

Two bus operations are required to issue a Clear Block Protection Configuration Register command:

- The first cycle writes the setup command
- The second write cycle specifies the address of the block to unprotect and confirms the command. If the command is not confirmed, the sequence is aborted and the device outputs the Status Register with bits 4 and 5 set to '1'.

To unprotect multiple blocks, the Clear Block Protection Configuration Register command must be repeated for each block.

Any attempt to unprotect a block already unprotected does not affect its status.

Table 10. Commands⁽¹⁾

							Ві	ıs oper	ations	i				
c	Command	Cycles	1st Cycle		2	2nd Cycle		3rd Cycle			4th Cycle			
		S	Ор.	Addr.	Data	Op.	Addr.	Data	Ор.	Addr.	Data	Op.	Addr.	Data
Read Memory Array		≥ 2	Write	Х	FFh	Read	RA	RD						
Read Elec	ctronic Signature ⁽²⁾	≥ 2	Write	Х	90h	Read	IDA	IDD						
Read Stat	tus Register	1	Write	Х	70h									
Read Que	ery	≥ 2	Write	Х	98h	Read	RA	RD						
Clear Status Register		1	Write	Х	50h									
Block Erase		2	Write	55h	20h	Write	ВА	D0h						
Erase All	Main Blocks	2	Write	55h	80h	Write	AAh	D0h						
Program	any block	2	Write	AAh	40h 10h	Write	PA	PD						
	OTP Block	2	Write	AAh	40h	Write	PA	PD						
Write to B	uffer and Program	N+4	Write	AAh	E8h	Write	ВА	N	Write	PA	PD	Write	Х	D0h
Program/l	Erase Suspend	1	Write	Х	B0h									
Program/I	Erase Resume	1	Write	Х	D0h									
Set Burst Register	Configuration	Š3	Write	Х	60h	Write	BCRh	03h	Read	RA	RD			
Set Block Protection Configuration Register		2	Write	Х	60h	Write	ВА	01h						
	ck Protection tion Register	2	Write	Х	60h	Write	ВА	D0h						

X Don't Care; RA Read Address, RD Read Data, ID Device Code, IDA Identifier Address, IDD Identifier Data, SRD Status Register Data, PA Program Address; PD Program Data, QA Query Address, QD Query Data, BA Any address in the Block, BCR Burst Configuration Register value, N+1 number of Words to program, BA Block address.

^{2.} The Manufacturer Code, the Device Code, the Burst Configuration Register, and the Block Protection Configuration Register of each block are read using the Read Electronic Signature command.

Table 11. Read Electronic Signature

Code	Device	Amax-A0	DQ31-DQ0		
Manufacturer	All	00000h	0000020h		
	M58BW16FT	00001h	0000883Ah		
Device	M58BW16FB	00001h	00008839h		
Device	M58BW32FT	00001h	00008838h		
	M58BW32FB	00001h	00008837h		
Burst Configuration Register		00005h	BCR ⁽¹⁾		
Block Protection	All	SBA+02h ⁽²⁾	00000000h (Unprotected)		
Configuration Register	All	SDA+UZII\	00000001h (Protected)		

^{1.} BCR = Burst Configuration Register.

Table 12. Program, Erase times and endurance cycles⁽¹⁾

Develope			- Unit		
Parameters	Min	Тур	Max	Oille	
Full Chip Program		15	20	S	
Double Word Program		15	35	μs	
512 Kbit Block Erase		1	2	s	
256 Kbit Block Erase		0.8	1.6	s	
64 Kbit Block Erase		0.6	1.2	s	
Program Suspend Latency Time			10	μs	
Erase Suspend Latency Time			30	μs	
Minimum effective erase time ⁽²⁾			30	μs	
Program/Erase Cycles (per Block)			100,000	cycles	

^{1.} $T_A = -40$ to 125°C, $V_{DD} = 2.7V$ to 3.6V, $V_{DDQ} = 2.6V$ to V_{DD}

^{2.} SBA is the start address of each block.

^{2.} The minimum effective erase time is defined as the minimum time required between the last Erase Resume command and the next Erase Suspend command for the internal Flash memory Program/Erase Controller to be able to execute its algorithm.

5 Status Register

The Status Register provides information on the current or previous Program, Erase or Block Protect operation. The various bits in the Status Register convey information and errors on the operation. They are output on DQ7-DQ0.

To read the Status Register the Read Status Register command can be issued. The Status Register is automatically read after Program, Erase, Block Protect, Program/Erase Resume commands. The Status Register can be read from any address.

The contents of the Status Register can be updated during an erase or program operation by toggling the Output Enable or Output Disable pins or by de-activating (Chip Enable, V_{IH}) and then reactivating (Chip Enable and Output Enable, V_{IL} , and Output Disable, V_{IH} .) the device.

The Status Register bits are summarized in *Table 13: Status Register Bits*. Refer to *Table 13* in conjunction with the following text descriptions.

5.1 Program/Erase Controller Status (Bit 7)

The Program/Erase Controller Status bit indicates whether the Program/Erase Controller is active or inactive. When the Program/Erase Controller Status bit is set to '0', the Program/Erase Controller is active; when bit7 is set to '1', the Program/Erase Controller is inactive.

The Program/Erase Controller Status is set to '0' immediately after a Program/Erase Suspend command is issued until the Program/Erase Controller pauses. After the Program/Erase Controller pauses the bit is set to '1'.

During Program and Erase operations the Program/Erase Controller Status bit can be polled to find the end of the operation. The other bits in the Status Register should not be tested until the Program/Erase Controller completes the operation and the bit is set to '1'.

After the Program/Erase Controller completes its operation the Erase Status (bit5), Program Status (bit4) bits should be tested for errors.

5.2 Erase Suspend Status (Bit 6)

The Erase Suspend Status bit indicates that an Erase operation has been suspended and is waiting to be resumed. The Erase Suspend Status should only be considered valid when the Program/Erase Controller Status bit is set to '1' (Program/Erase Controller inactive); after a Program/Erase Suspend command is issued the memory may still complete the operation rather than entering the Suspend mode.

When the Erase Suspend Status bit is set to '0', the Program/Erase Controller is active or has completed its operation; when the bit is set to '1', a Program/Erase Suspend command has been issued and the memory is waiting for a Program/Erase Resume command.

When a Program/Erase Resume command is issued the Erase Suspend Status bit returns to '0'.

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5.3 Erase Status (Bit 5)

The Erase Status bit can be used to identify if the memory has failed to verify that the block has erased correctly. The Erase Status bit should be read once the Program/Erase Controller Status bit is High (Program/Erase Controller inactive).

When the Erase Status bit is set to '0', the memory has successfully verified that the block has erased correctly. When the Erase Status bit is set to '1', the Program/Erase Controller has applied the maximum number of pulses to the block and still failed to verify that the block has erased correctly.

Once set to '1', the Erase Status bit can only be reset to '0' by a Clear Status Register command or a hardware reset. If set to '1' it should be reset before a new Program or Erase command is issued, otherwise the new command will appear to fail.

5.4 Program/ Write to Buffer and Program Status (Bit 4)

The Program/Write to Buffer and Program Status bit is used to identify a Program failure or a Write to Buffer and Program failure. Bit4 should be read once the Program/Erase Controller Status bit is High (Program/Erase Controller inactive).

When bit 4 is set to '0' the memory has successfully verified that the device has programmed correctly. When bit 4 is set to '1' the device has failed to verify that the data has been programmed correctly.

Once set to 1', the Program Status bit can only be reset to '0' by a Clear Status Register command or a hardware reset. If set to '1' it should be reset before a new Program or Erase command is issued, otherwise the new command will appear to fail.

5.4.1 PEN Status (Bit 3)

The PEN Status bit can be used to identify if a program or erase operation has been attempted when PEN is Low, $V_{\rm II}$.

When Bit 3 is set to '0' no program or erase operations have been attempted with PEN Low, V_{IL} , since the last Clear Status Register command, or hardware reset.

When Bit 3 is set to '1' a program or erase operation has been attempted with PEN Low, V_{II}.

Once set to '1', Bit 3 can only be reset by an Clear Status Register command or a hardware reset. If set to '1' it should be reset before a new program or erase command is issued, otherwise the new command will appear to fail.

5.5 Program Suspend Status (Bit 2)

The Program Suspend Status bit indicates that a Program operation has been suspended and is waiting to be resumed. The Program Suspend Status should only be considered valid when the Program/Erase Controller Status bit is set to '1' (Program/Erase Controller inactive); after a Program/Erase Suspend command is issued the memory may still complete the operation rather than entering the Suspend mode.

When the Program Suspend Status bit is set to '0', the Program/Erase Controller is active or has completed its operation; when the bit is set to '1', a Program/Erase Suspend command has been issued and the memory is waiting for a Program/Erase Resume command.

When a Program/Erase Resume command is issued the Program Suspend Status bit returns to '0'.

5.6 Block Protection Status (Bit 1)

The Block Protection Status bit can be used to identify if a Program or Erase operation has tried to modify the contents of a protected block.

When the Block Protection Status bit is set to '0', no Program or Erase operations have been attempted to protected blocks since the last Clear Status Register command or hardware reset; when the Block Protection Status bit is set to '1', a Program or Erase operation has been attempted on a protected block.

Once set to '1', the Block Protection Status bit can only be reset Low by a Clear Status Register command or a hardware reset. If set to '1' it should be reset before a new Program or Erase command is issued, otherwise the new command will appear to fail.

5.7 Bit 0

Reserved bit (set to '1').

Table 13. Status Register Bits

Bit	Name	Logic Level	Definition
7	Drogram/Erosa Controller Status	'1'	Ready
_ ′	Program/Erase Controller Status	'0'	Busy
6	Erase Suspend Status	'1'	Suspended
0	Erase Suspend Status	'0'	In Progress or Completed
F	Erase Status	'1'	Erase Error
5	Erase Status	'0'	Erase Success
4	Dragram Status	'1'	Program Error
4	Program Status,	'0'	Program Success
3	PEN Status bit	'0'	no program or erase attempted
3	PEN Status bit	'1'	program or erase attempted
2	Dragram Cuanand Status	'1'	Suspended
2	Program Suspend Status	'0'	In Progress or Completed
1	Erase/Program in a Protected	'1'	program/erase on protected block, abort
	DIOCK	'0'	No operations to protected blocks
0	Reserved	'1'	Reserved

6 Maximum rating

Stressing the device above the ratings listed in *Table 14: Absolute maximum ratings*, may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 14. Absolute maximum ratings

Symbol	Parameter	Va	Unit	
Symbol	raiametei	Min	Max	Offic
T _{BIAS}	Temperature Under Bias	-40	125	°C
T _{STG}	Storage Temperature	- 55	155	°C
V _{IO}	Input or Output Voltage	-0.6	V _{DDQ} +0.6 V _{DDQIN} +0.6	V
V_{DD} , V_{DDQ} , V_{DDQIN}	Supply Voltage	-0.6	4.2	V

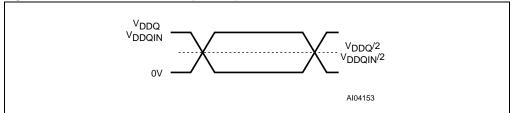
7 DC and AC parameters

This section summarizes the operating and measurement conditions, and the DC and AC characteristics of the device. The parameters in the DC and AC characteristics Tables that follow, are derived from tests performed under the Measurement Conditions summarized in *Table 15: Operating and AC measurement conditions*. Designers should check that the operating conditions in their circuit match the measurement conditions when relying on the quoted parameters.

Table 15. Operating and AC measurement conditions

			M58BW16F, M58BW32F				
Parameter	45	ns	55	Units			
		Min	Max	Min	Max		
Supply Voltage (V _{DD})		2.7	3.6	2.5	3.3	V	
Input/Output Supply Voltage (V _{DDQ})		2.4	3.6	2.4	3.6	V	
Ambient Temperature (T _A)	Grade 3	-40	125	-40	125	°C	
Load Capacitance (C _L)		3	0	3	0	pF	
Clock Rise and Fall Times			3		3	ns	
Input Rise and Fall Times			3		3	ns	
Input Pulses Voltages		0 to V _{DDQ}		0 to V _{DDQ}		V	
Input and Output Timing Ref. Voltages	3	V _{DDQ} /2		V _{DDQ} /2		V	

Figure 5. AC measurement input/output waveform



1. $V_{DD} = V_{DDQ}$.

Figure 6. AC measurement load circuit

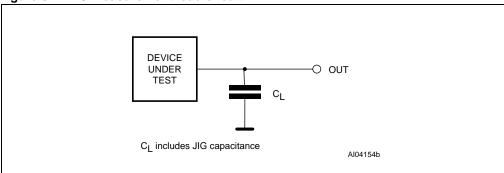


Table 16. Device capacitance⁽¹⁾⁽²⁾

Symbol	Parameter	Test Condition	Тур	Max	Unit
C _{IN}	Input Capacitance	V _{IN} = 0V	6	8	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0V	8	12	pF

^{1.} $T_A = 25^{\circ}C$, f = 1 MHz

Table 17. DC characteristics

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
I _{LI}	Input Leakage Current	0V≤V _{IN} ≤V _{DDQ}			±1	μA
I _{LO}	Output Leakage Current	0V≤V _{OUT} ≰V _{DDQ}			±5	μA
I _{DD} ⁽¹⁾	Supply Current (Random Read)	$\overline{E} = V_{IL}, \overline{G} = V_{IH},$ $f_{add} = 6MHz$			25	mA
I _{DDP-UP} ⁽²⁾	Supply Current (Power-up)				20	mA
I _{DDB} ⁽¹⁾	Supply Current (Burst Read)	$\overline{E} = V_{IL}, \overline{G} = V_{IH},$ $f_{clock} = 75MHz$			50	mA
I _{DD1} ⁽¹⁾	Supply Current (Standby)	$\overline{E} = \overline{RP} = V_{DD} \pm 0.2V$			150	μA
I _{DD2} ⁽¹⁾	Supply Current (Program or Erase)	Program, Erase in progress			30	mA
I _{DD3} ⁽¹⁾	Supply Current (Erase/Program Suspend)	E = V _{IH}			150	μA
I _{DD4} ⁽¹⁾	Supply Current (Standby Disable)			5	10	mA
V _{IL}	Input Low Voltage		-0.5		0.2V _{DDQIN}	V
V _{IH}	Input High Voltage (for DQ lines)		0.8V _{DDQIN}		V _{DDQ} +0.3	٧
V _{IH}	Input High Voltage (for Input only lines)		0.8V _{DDQIN}		3.6	V
V _{OL}	Output Low Voltage	I _{OL} = 100μA			0.1	V
V _{OH}	Output High Voltage CMOS	I _{OH} = -100μA	V _{DDQ} -0.1			V
V _{LKO}	V _{DD} Supply Voltage (Erase and Program lockout)				2.2	V

The Standby mode can be disabled by setting the Standby Disable bit (M14) of the Burst Configuration Register to '1'.

^{2.} Sampled only, not 100% tested.

I_{DDP-UP} is defined only during the power-up phase, from the moment current is applied with RP Low to the
moment when the supply voltage has become stable and RP is brought to High.

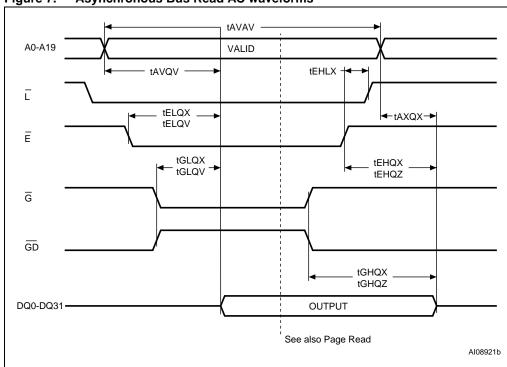
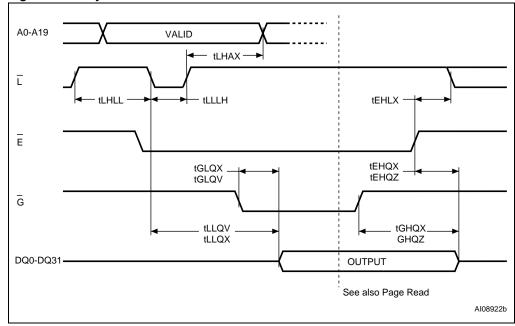


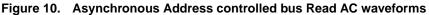
Figure 7. Asynchronous Bus Read AC waveforms





A0-A19 VALID tLHAX Ĺ tEHLX -Ē tEHQX tEHQZ tGLQX tGLQV Ġ tELQX tGHQX. tELQV GHQZ DQ0-DQ31 OUTPUT See also Page Read AI13434

Figure 9. Asynchronous Chip Enable controlled bus Read AC waveforms



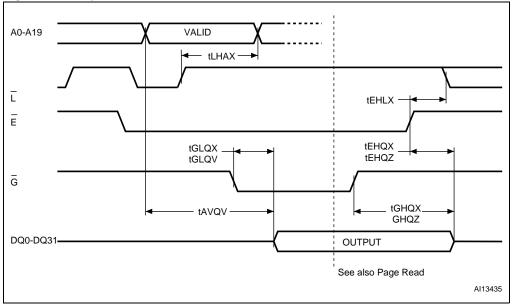


Table 18. Asynchronous Bus Read AC characteristics

Cumbal	Davamatar	Took Comdisi	M58B	l Init		
Symbol	Parameter	Test Conditi	on	45	55	Unit
t _{AVAV}	Address Valid to Address Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	Min	45	55	ns
t _{AVQV}	Address Valid to Output Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	Max	45	55	ns
t _{AXQX}	Address Transition to Output Transition	$\overline{L} = V_{IL}, \overline{G} = V_{IL}$	Min	0	0	ns
t _{EHLX}	Chip Enable High to Latch Enable Transition		Min	0	0	ns
t _{EHQX}	Chip Enable High to Output Transition	G = V _{IL}	Min	0	0	ns
t _{EHQZ}	Chip Enable High to Output Hi-Z	G = V _{IL}	Max	20	20	ns
t _{ELQV} ⁽¹⁾	Chip Enable Low to Output Valid	$\overline{G} = V_{IL}$	Max	45	55	ns
t _{GHQX}	Output Enable High to Output Transition	E = V _{IL}	Min	0	0	ns
t _{GHQZ}	Output Enable High to Output Hi-Z	E = V _{IL}	Max	15	15	ns
t _{GLQV}	Output Enable Low to Output Valid	E = V _{IL}	Max	15	15	ns
t _{GLQX}	Output Enable Low to Output Transition	E = V _{IL}	Min	0	0	ns
t _{LHAX}	Latch Enable High to Address Transition	$\overline{E} = V_{IL}$	Min	5	5	ns
t _{LHLL}	Latch Enable High to Latch Enable Low		Min	10	10	ns
t _{LLLH}	Latch Enable Low to Latch Enable High	E = V _{IL}	Min	10	10	ns
t _{LLQV}	Latch Enable Low to Output Valid Chip Enable Low to Output Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	Max	45	55	ns
t _{LLQX}	Latch Enable Low to Output Transition	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	Min	0	0	ns
t _{ELQX}	Chip Enable Low to Output Transition	$\overline{L} = V_{IL}, \overline{G} = V_{IL}$	Min	0	0	ns

Output Enable G may be delayed up to t_{ELQV} - t_{GLQV} after the falling edge of Chip Enable E without increasing t_{ELQV}.

Figure 11. Asynchronous Page Read AC waveforms

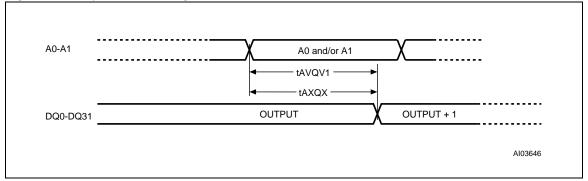


Table 19. Asynchronous Page Read AC characteristics⁽¹⁾

Symbol	Parameter	Test Condition	M58B	Unit		
Symbol Parameter		rest condition	45		55	
t _{AVQV1}	Address Valid to Output Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	Max	25	25	ns
t _{AXQX}	Address Transition to Output Transition	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	Min	0	0	ns

^{1.} For other timings see *Table 18: Asynchronous Bus Read AC characteristics*.

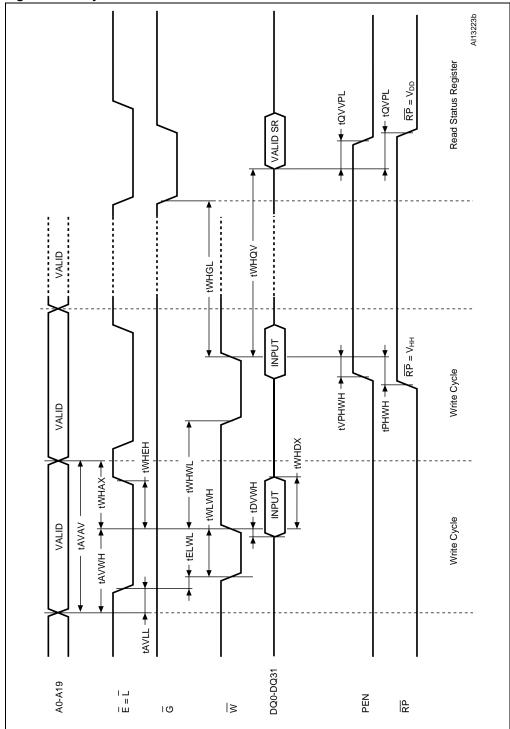


Figure 12. Asynchronous Write AC waveform

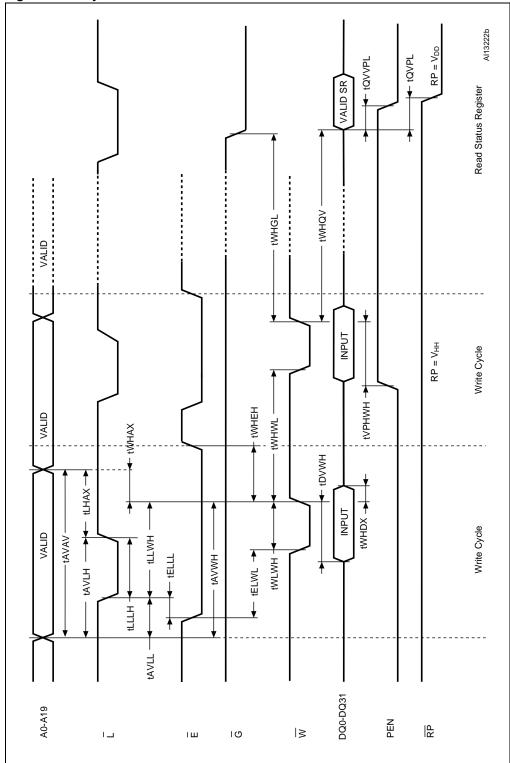


Figure 13. Asynchronous Latch controlled Write AC waveform

Table 20. Asynchronous Write and Latch controlled Write AC characteristics

0	Barrandan	Total October	1241	M58B	1114	
Symbol	Parameter	Test Cond	dition	45	55	Unit
t _{AVAV}	Address Valid toAddress Valid		Min	45	55	
t _{AVLH}	Address Valid to Latch Enable High		Min	8	8	ns
t _{AVLL}	Address Valid to Latch Enable Low		Min	0	0	ns
t _{AVWH}	Address Valid to Write Enable High	$\overline{E} = V_{IL}$	Min	25	25	ns
t _{DVWH}	Data Input Valid to Write Enable High	$\overline{E} = V_{IL}$	Min	25	25	ns
t _{ELLL}	Chip Enable Low to Latch Enable Low		Min	0	0	ns
t _{ELWL}	Chip Enable Low to Write Enable Low		Min	0	0	ns
t _{LHAX}	Latch Enable High to Address Transition		Min	5	5	ns
t _{LLLH}	Latch Enable Low to Latch Enable High		Min	10	10	ns
t _{LLWH}	latch Enable Low to Write Enable High	$\overline{E} = V_{IL}$	Min	25	25	ns
t _{QVVPL}	Output Valid to PEN Low		Min	0	0	ns
t _{VPHWH}	PEN High to Write Enable High		Min	0	0	ns
t _{WHAX}	Write Enable High to Address Transition	$\overline{E} = V_{IL}$	Min	0	0	ns
t _{WHDX}	Write Enable High to Input Transition	$\overline{E} = V_{IL}$	Min	0	0	ns
t _{WHEH}	Write Enable High to Chip Enable High		Min	0	0	ns
t _{WHGL}	Write Enable High to Output Enable Low		Min	150	150	ns
t _{WHQV}	Write Enable High to Output Valid		Min	165	165	ns
t _{WHWL}	Write Enable High to Write Enable Low		Min	20	20	ns
t _{WLWH}	Write Enable Low to Write Enable High	$\overline{E} = V_{IL}$	Min	25	25	ns
t _{QVPL}	Output Valid to Reset/Power-down Low		Min	0	0	ns

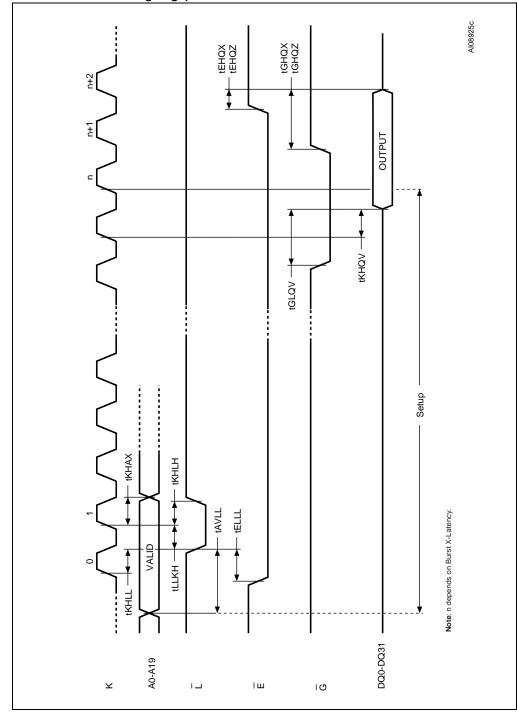


Figure 14. Synchronous Burst Read, Latch Enable controlled (data valid from 'n' clock rising edge)

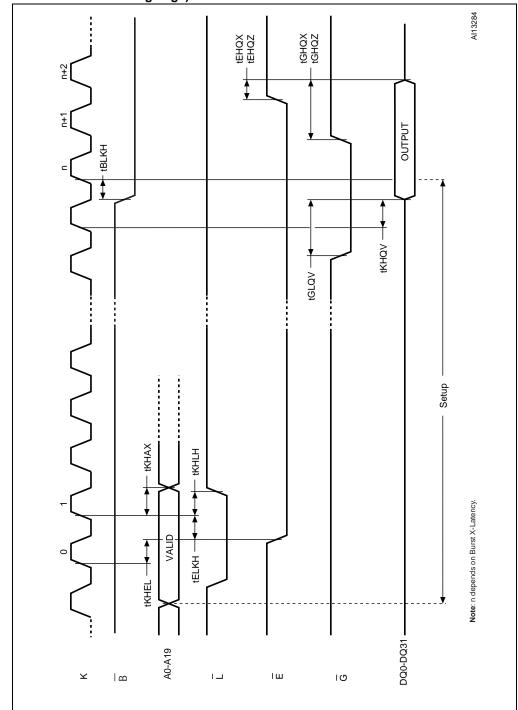


Figure 15. Synchronous Burst Read, Chip Enable controlled (data valid from 'n' clock rising edge)

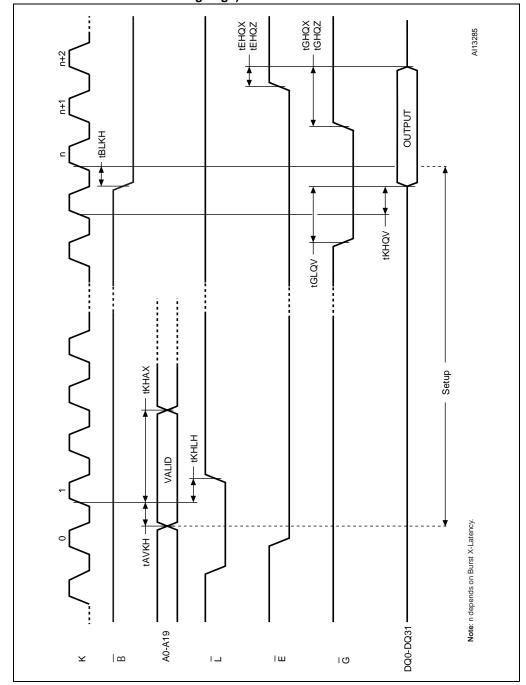


Figure 16. Synchronous Burst Read, Valid Address transition controlled (data valid from 'n' clock rising edge)

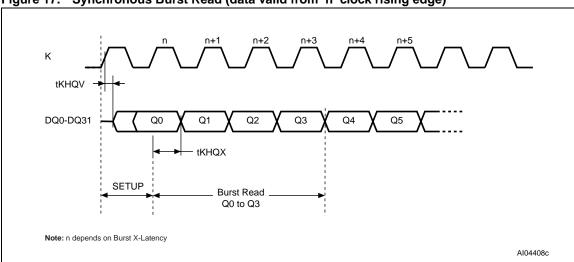
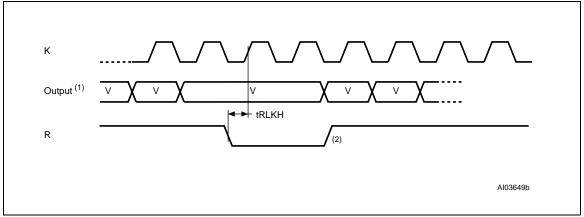


Figure 17. Synchronous Burst Read (data valid from 'n' clock rising edge)

1. For set up signals and timings see Synchronous Burst Read.

Figure 18. Synchronous Burst Read - valid data ready output



- 1. Valid Data Ready = Valid Low during valid clock edge
- 2. V= Valid output.
- 3. The internal timing of R follows DQ.

Figure 19. Synchronous Burst Read - burst address advance

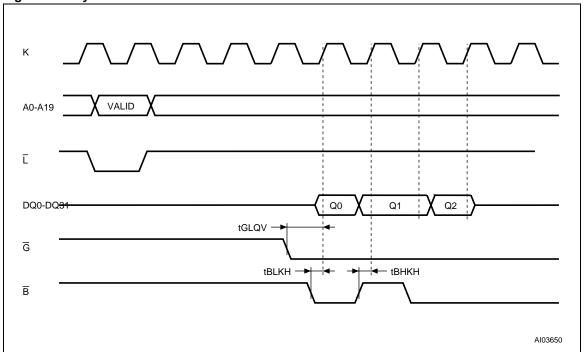


Figure 20. Clock input AC waveform

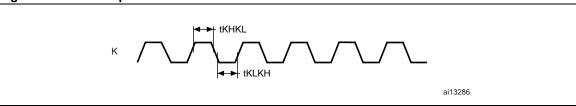


Table 21. Synchronous Burst Read AC characteristics^{(1) (2)}

0	Bananadan	Total Constitution		M58BWxxF		
Symbol	Parameter	Test Condition		45	55	Unit
		X-Latency = 3	Max	40	33	MHz
f	Clock frequency	X-Latency = 4	Max	56	40	MHz
		X-Latency = 5 or 6	Max	75	56	MHz
		$\overline{E} = V_{IL}, \overline{L} = V_{IL}$ X-Latency = 3	Min	9	6	ns
t _{AVKH}	Address Valid to Valid Clock Edge,	$\overline{E} = V_{IL}, \overline{L} = V_{IL}$ X-Latency = 4, 5 or 6	Min	6	6	ns
t _{KHKL}	Clock High Time		Min	6	6	ns
t _{KLKH}	Clock Low Time		Min	6	6	ns
t _{BHKH}	Burst Address Advance High to Valid Clock Edge	$\overline{E} = V_{IL}, \overline{G} = V_{IL}, \overline{L} = V_{IH}$	Min	8	8	ns
t _{BLKH}	Burst Address Advance Low to Valid Clock Edge	$\overline{E} = V_{IL}, \overline{G} = V_{IL}, \overline{L} = V_{IH}$	Min	8	8	ns
	Chip Enable Low to Valid Clock Edge	$\overline{L} = V_{IL}$ X-Latency = 3	Min	9	6	ns
t _{ELKH}	Crip Enable Low to Valid Glock Eage	$\overline{L} = V_{IL}$ X-Latency = 4, 5 or 6	Min	6	6	ns
t _{GLQV}	Output Enable Low to Output Valid	$\overline{E} = V_{IL}, \overline{L} = V_{IH}$	Max	15	15	ns
t _{KHAX}	Valid Clock Edge to Address Transition	$\overline{E} = V_{IL}$	Min	5	5	ns
t _{KHEL}	Valid Clock Edge to Chip Enable Low	$\overline{L} = V_{IL}$	Min	0	0	ns
t _{KHLL}	Valid Clock Edge to Latch Enable Low	$\overline{E} = V_{IL}$	Min	0	0	ns
t _{KHLH}	Valid Clock Edge to Latch Enable High	$\overline{E} = V_{IL}$	Min	0	0	ns
t _{KHQX}	Valid Clock Edge to Output Transition	$\overline{E} = V_{IL}, \overline{G} = V_{IL}, \overline{L} = V_{IH}$	Min	2	2	ns
t	Latch Enable Low to Valid Clock Edge,	$\overline{E} = V_{IL}$ X-Latency = 3	Min	9	6	ns
[†] LLKH	Later Eriable Low to valid Glock Edge,	$\overline{E} = V_{IL}$ X-Latency = 4, 5 or 6	Min	6	6	ns
t _{RLKH}	Valid Data Ready Low to Valid Clock Edge	$\overline{E} = V_{IL}, \overline{G} = V_{IL}, \overline{L} = V_{IH}$	Min	6	6	ns
t _{KHQV}	Valid Clock Edge to Output Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}, \overline{L} = V_{IH}$	Max	8	8	ns

^{1.} Data output should be read on the valid clock edge.

^{2.} For other timings see Table 18: Asynchronous Bus Read AC characteristics.

W, E, G

tPHWL
tPHEL
tPHGL

R

VDD, VDDQ

Power-Up

Reset

Al03849b

Figure 21. Reset, Power-Down and Power-up AC waveform

Table 22. Reset, Power-Down and Power-up AC characteristics

Symbol	Parameter	Min	Max	Unit
t _{PHEL}	Reset/Power-down High to Chip Enable Low	50		ns
t _{PHQV} (1)	Reset/Power-down High to Output Valid		130	ns
t _{PHWL}	Reset/Power-down High to Write Enable Low	50		ns
t _{PHGL}	Reset/Power-down High to Output Enable Low	50		ns
t _{PLPH}	Reset/Power-down Low to Reset/Power-down High	100		ns
t _{PLRH}	Reset/Power-down Low to Valid Data Ready High	2	30	μs
t _{VDHPH}	Supply Voltages High to Reset/Power-down High	50		μs

^{1.} This time is $t_{\rm PHEL}$ + $t_{\rm AVQV}$ or $t_{\rm PHEL}$ + $t_{\rm ELQV}$.

8 Package mechanical

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second-level interconnect. The category of Second-Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97.

The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.

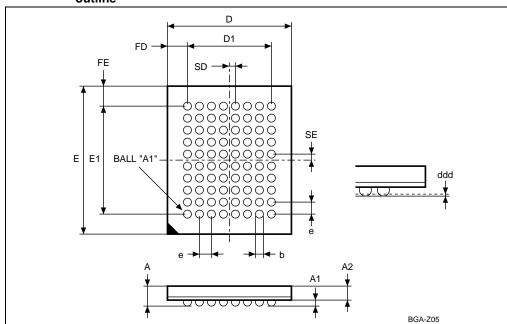


Figure 22. LBGA80 10 x 12mm - 8 x 10 ball array, 1mm pitch, bottom view package outline

1. Drawing is not to scale.

Table 23. LBGA80 10 \times 12mm - 8 \times 10 active ball array, 1mm pitch, package mechanical data

Symbol		millimeters			inches	
Symbol	Тур		Max	Тур	Min	Max
А			1.700			0.0669
A1		0.350			0.0138	
A2	1.100			0.0433		
b	0.500			0.0197		
D	10.000	_	_	0.3937	-	_
D1	7.000	-	-	0.2756	-	-
ddd			0.120			0.0047
E	12.000	_	_	0.4724	-	_
E1	9.000	_	_	0.3543	-	_
е	1.000	_	-	0.0394	-	-
FD	1.500	-	-	0.0591	-	-
FE	1.500	_	_	0.0591	-	_
SD	0.500	_	-	0.0197	-	-
SE	0.500	_	_	0.0197	-	_

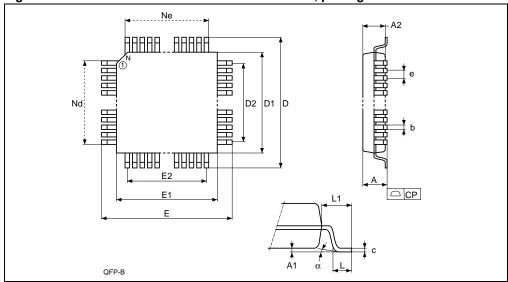


Figure 23. PQFP80 - 80 lead Plastic Quad Flat Pack, package outline

1. Drawing is not to scale.

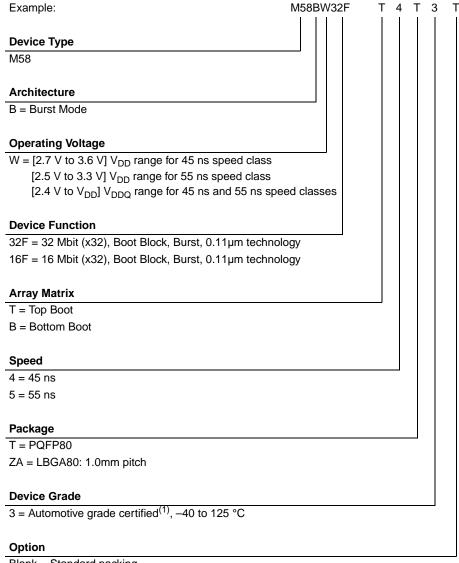
Table 24. PQFP80 - 80 lead Plastic Quad Flat Pack, package mechanical data

		millimeters	·	don, paonag	inches	
Symbol	Typ Min		Max	Тур	Min	Max
Α			3.400			0.1339
A1		0.250			0.0098	
A2	2.800	2.550	3.050	0.1102	0.1004	0.1201
b		0.300	0.450		0.0118	0.0177
СР			0.100			0.0039
С		0.130	0.230		0.0051	0.0091
D	23.200	22.950	23.450	0.9134	0.9035	0.9232
D1	20.000	19.900	20.100	0.7874	0.7835	0.7913
D2	18.400	-	_	0.7244	-	-
е	0.800	-	_	0.0315	-	-
Е	17.200	16.950	17.450	0.6772	0.6673	0.6870
E1	14.000	13.900	14.100	0.5512	0.5472	0.5551
E2	12.000	-	_	0.4724	-	-
L	0.800	0.650	0.950	0.0315	0.0256	0.0374
L1	1.600	-	-	0.0630	-	-
α		0°			0°	7°
N		80			80	
Nd		24			24	
Ne		16			16	

5//

9 Part numbering

Table 25. Ordering information scheme



Blank = Standard packing

T = Tape & Reel Packing

F = ECOPACK® Package, Tape & Reel 24mm Packing

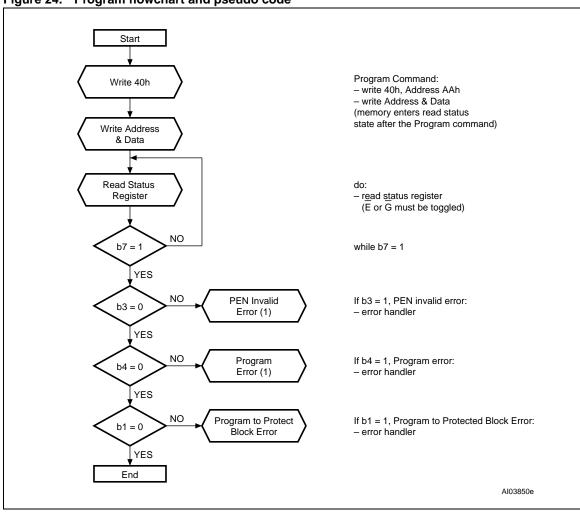
 Qualified & characterized according to AEC Q100 & Q003 or equivalent, advanced screening according to AEC Q001 & Q002 or equivalent.

Devices are shipped from the factory with the memory content bits erased to '1'. For a list of available options (Speed, Package, etc) or for further information on any aspect of this device, please contact the ST Sales Office nearest to you.

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Appendix A Flowcharts





^{1.} If an error is found, the Status Register must be cleared before further P/E operations.

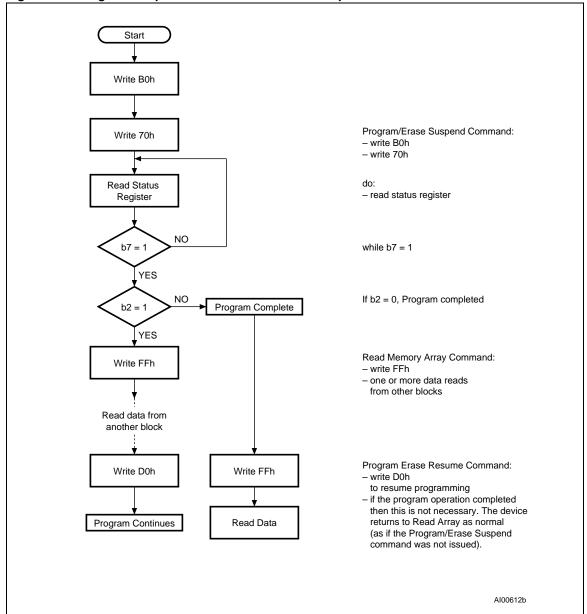


Figure 25. Program Suspend & Resume flowchart and pseudo code

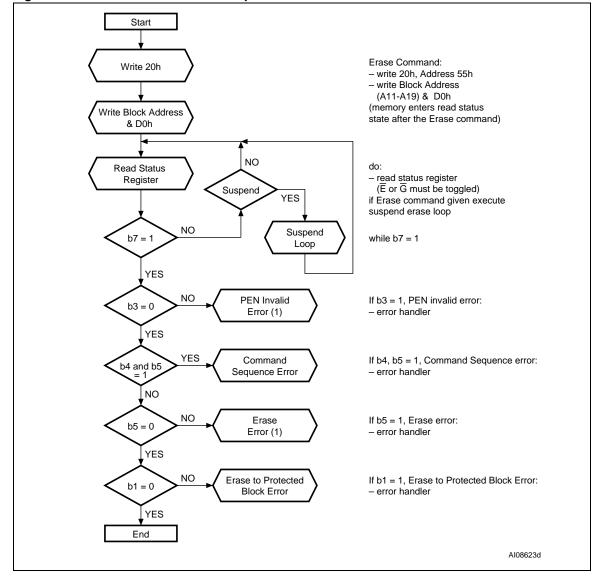


Figure 26. Block Erase flowchart and pseudo code

1. If an error is found, the Status Register must be cleared before further P/E operations.

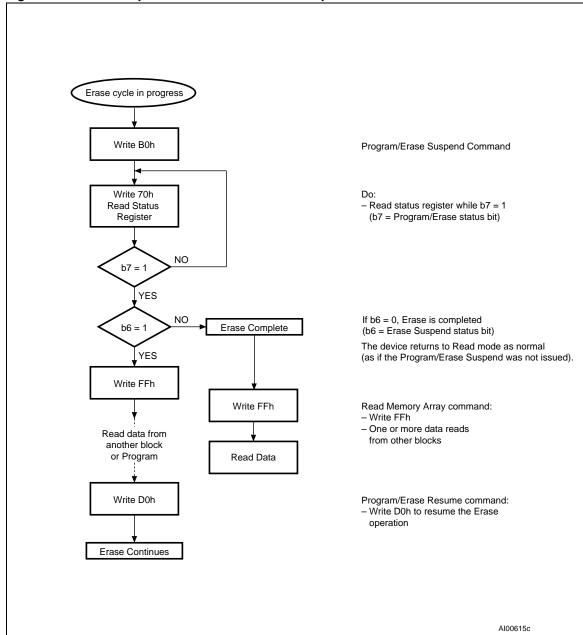


Figure 27. Erase Suspend & Resume flowchart and pseudo code

Power-up or Reset

Asynchronous Read

Write 60h command

Write 03h with A15-A0
BCR inputs

BCR bit 15 = '1'

Set Burst Configuration Register Command:

- write 60h

write 03h
and BCR on A15-A0

BCR bit 15 = '0'
BCR bit 14-bit 0 = '1'

A103834

Figure 28. Power-up sequence followed by Synchronous Burst Read

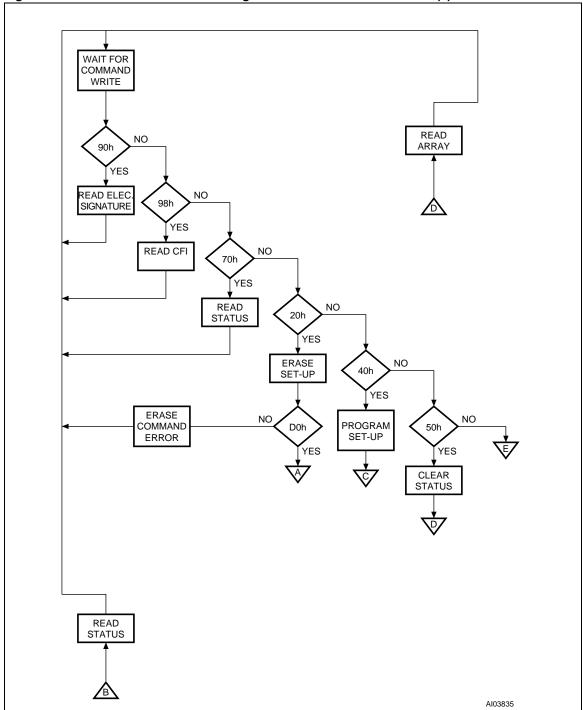


Figure 29. Command Interface and Program Erase Controller flowchart (a)

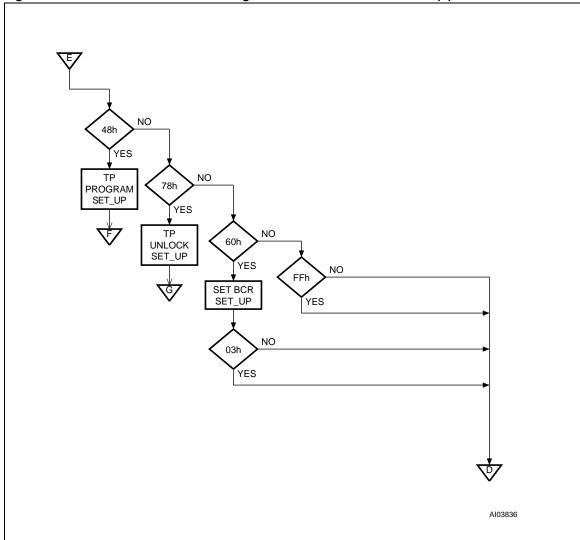


Figure 30. Command Interface and Program Erase Controller flowchart (b)

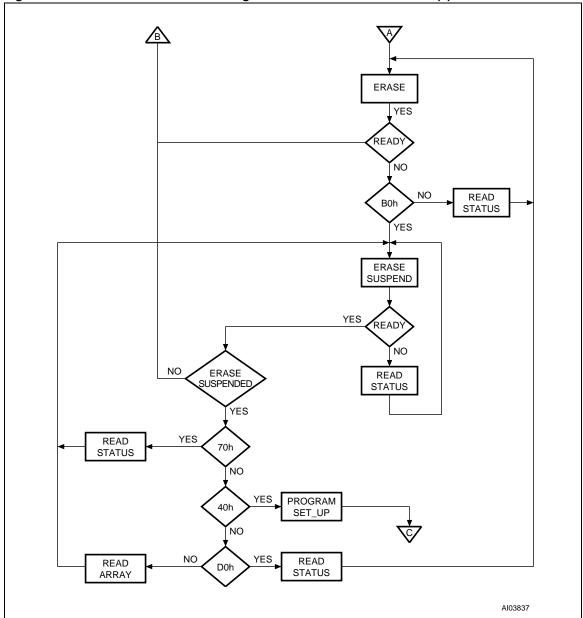


Figure 31. Command Interface and Program Erase Controller flowchart (c)

Downloaded from Elcodis.com electronic components distributor

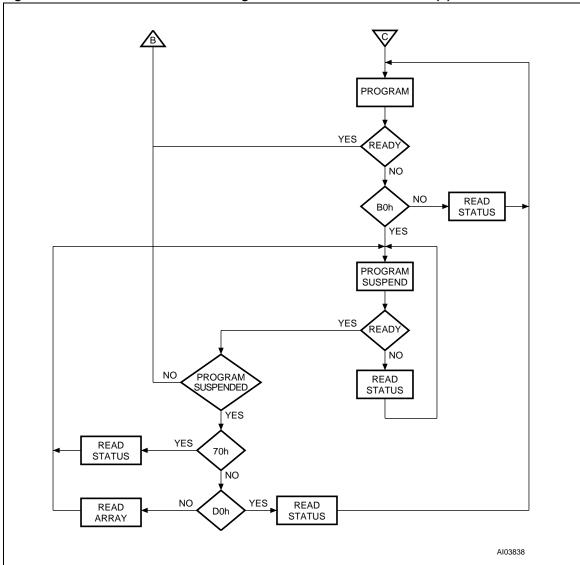


Figure 32. Command Interface and Program Erase Controller flowchart (d)

Figure 33. Command Interface and Program Erase Controller flowchart (e) TP PROGRAM READ STATUS TP UNLOCK YES READ STATUS AI03839

Appendix B Common Flash Interface (CFI)

The Common Flash Interface is a JEDEC approved, standardized data structure that can be read from the Flash memory device. It allows a system software to query the device to determine various electrical and timing parameters, density information and functions supported by the memory. The system can interface easily with the device, enabling the software to upgrade itself when necessary.

When the CFI Query Command (RCFI) is issued the device enters CFI Query mode and the data structure is read from the memory. *Table 26, Table 27, Table 28, Table 31* and *Table 30* show the addresses used to retrieve the data.

Table 26. Query structure overview

Offset	Sub-section Name	Des	cription
00h	0020h	Manufacturer Code	ST
01h	883A 8839 8838 8837	Device Code	M58BW16FT (top) M58BW16FB (bottom) M58BW32FT (top) M58BW32FB (bottm)
10h	CFI Query Identification String	Command set ID an	d algorithm data offset
1Bh	System Interface Information	Device timing and ve	oltage information
27h	Device Geometry Definition	Flash memory layou	ıt
P(h) ⁽¹⁾	Primary Algorithm-specific Extended Query Table	Additional information Primary Algorithm (
A(h) ⁽²⁾	Alternate Algorithm-specific Extended Query Table	Additional information Alternate Algorithm	

^{1.} Offset 15h defines P which points to the Primary Algorithm Extended Query Address Table.

^{2.} Offset 19h defines A which points to the Alternate Algorithm Extended Query Address Table.

Table 27. CFI - Query address and data output^{(1) (2)}

Address A0-Amax	Data		Instruction
10h	51h	"Q"	51h; "Q"
11h	52h	"R"	Query ASCII String 52h; "R"
12h	59h	"Y"	59h; "Y"
13h	03	h	Primary Vendor:
14h	00h		Command Set and Control Interface ID Code
15h	35h (M58BW16F) 39h (M58BW32F)		Primary algorithm extended Query Address Table: P(h)
16h	00	h	(1)
17h	00	h	Alternate Vendor:
18h	00h		Command Set and Control Interface ID Code
19h	00h		Alternate Algorithm Extended Query address Table
1Ah	00	h	Alternate Algorithm Extended Query address Table

^{1.} The x8 or Byte Address and the x16 or Word Address mode are not available.

Table 28. CFI - Device voltage and timing specification

Address A0-Amax	Data	Description	Value
1Bh	27h ⁽¹⁾	V _{DD} min	2.7 V
1Ch	36h ⁽¹⁾	V _{DD} max	3.6 V
1Dh	xxxx xxxxh	Reserved	
1Eh	xxxx xxxxh	Reserved	
1Fh	04h	2 ⁿ µs typical for Word, DWord prog	
20h	xxxx xxxxh	Reserved	
21h	0Ah	2 ⁿ ms, typical time-out for Erase Block	1 s
22h	xxxx xxxxh	Reserved	
23h	xxxx xxxxh	Reserved	
24h	xxxx xxxxh	Reserved	
25h	xxxx xxxxh	Reserved	
26h	xxxx xxxxh	Reserved	

^{1.} Bits are coded in Binary Code Decimal, bit7 to bit4 are scaled in Volts and bit3 to bit0 in mV.

^{2.} Query Data are always presented on DQ7-DQ0. DQ31-DQ8 are set to '0'.

Table 29. M58BW16F device geometry definition

Address A0-Amax	Data	Description	Value	
27h	15h	2 ⁿ number of bytes memory size	2 MBytes	
28h	03h	Device Interface Sync./Async.	x32	
29h	00h	Organization Sync./Async.	Async.	
2Ah	00h	Maximum number of Byte in multi-Byte program = 2 ⁿ	32 Bytes	
2Bh	00h	Maximum number of Byte in muiti-Byte program = 2	32 Bytes	
2Ch	02h	Bit7-0 = number of Erase Block Regions in device	2	
2Dh	1Eh	Number (n-1) of erase blocks of identical size; n=31	31 blocks	
2Eh	00h	Number (II-1) or erase blocks or identical size, II=31	31 DIOCKS	
2Fh	00h	Erase Block region information x 256 bytes per Erase	512 Kbits	
30h	01h	Block (64 Kbytes)	512 KDIIS	
31h	07h	Number (s. 1) of cross blocks of identical circus.	8 blocks	
32h	00h	Number (n-1) of erase blocks of identical size; n=8	O DIOCKS	
33h	20h	Erase Block region information x 256 bytes per Erase	64 Khita	
34h	00h	Block (8 Kbytes)	64 Kbits	

Table 30. M58BW16F extended query information

Address offset	Address Amax-A0	Data	(Hex)	Description
(P)h	35h	50	Р	
(P+1)h	36h	52	R	Query ASCII string - Extended Table
(P+2)h	37h	49	Υ	
(P+3)h	38h	3	1h	Major revision number
(P+4)h	39h	3	1h	Minor revision number
(P+5)h	3Ah	86	6h	Optional Feature: (1=yes, 0=no) bit0, Chip Erase Supported (0= no) bit1, Suspend Erase Supported (1=yes) bit2, Suspend Program Supported (1=yes) bit3, Lock/Unlock Supported (0=no) bit4, Queue Erase Supported (0=no) bit5, Instant individual block locking (0=no) bit6, Protection bits supported (0=no) bit7, Page read supported (1=yes) bit8, Synchronous read supported (1=yes) Bit 9 reserved
(P+6)h	3Bh	01h		
(P+7)h	3Ch	00h		Synchronous read supported
(P+8)h	3Dh	00)h	

Table 30. M58BW16F extended query information (continued)

Address offset	Address Amax-A0	Data (Hex)	Description
(P+9)h	3Eh	01h	Function allowed after Suspend: Program allowed after Erase Suspend (1=yes) Bit 7-1 reserved for future use
(P+A)h-(P+40)h	3Fh-7Fh		Reserved
(P+41)h	80h	xxxx xxxxh	Unique Device ID - 1 (16 bits)
(P+42)h	81h	xxxx xxxxh	Unique Device ID - 2 (16 bits)
(P+43)h	82h	xxxx xxxxh	Unique Device ID - 3 (16 bits)
(P+44)h	83h	xxxx xxxxh	Unique Device ID - 4 (16 bits)

Table 31. M58BW32F device geometry definition

Address A0-Amax	Data	Description	Value
27h	16h	2 ⁿ number of bytes memory size	4 MBytes
28h	03h	Device Interface Sync./Async.	x32
29h	00h	Organization Sync./Async.	Async.
2Ah	05h	Page size in butes 20	22 Putos
2Bh	00h	Page size in bytes, 2 ⁿ	32 Bytes
2Ch	03h	Bit7-0 = number of Erase Block Regions in device	3
2Dh	3Dh	Number (n-1) of Erase Block Regions of identical	62
2Eh	00h	size; n = 62	02
2Fh	00h	Erase Block region information x 256 bytes per Erase	512 Kbits
30h	01h	Block (64 Kbytes)	512 KDIIS
31h	07h	Number (n-1) of Erase blocks of identical size; n = 8	8 blocks
32h	00h	Number (11-1) of Erase blocks of Identical Size, II = 0	O DIOCKS
33h	20h	Erase Block region information x 256 bytes per Erase	64 Kbits
34h	00h	Block (8 Kbytes)	64 KDIIS
35h	03h	Number (n. 1) of Ergon Plank of identical size: n 4	4 blocks
36h	00h	Number (n-1) of Erase Block of identical size; n = 4	4 DIUCKS
37h	40h	Erase Block Region Information x 256 bytes per	128 Kbits
38h	00h	Erase block (16 Kbytes)	120 KUIIS

Table 32. M58BW32F Extended query information

Address offset	Address Amax-A0	Data	(Hex)	Description
(P)h	39h	50	Р	
(P+1)h	3Ah	52	R	Query ASCII string - Extended Table
(P+2)h	3Bh	49	Υ	
(P+3)h	3Ch	3	1h	Major revision number
(P+4)h	3Dh	3	1h	Minor revision number
(P+5)h	3Eh	86h		Optional Feature: (1=yes, 0=no) bit0, Chip Erase Supported (0= no) bit1, Suspend Erase Supported (1=yes) bit2, Suspend Program Supported (1=yes) bit3, Lock/Unlock Supported (0=no) bit4, Queue Erase Supported (0=no) bit5, Instant individual block locking (0=no) bit6, Protection bits supported (0=no) bit7, Page read supported (1=yes) bit8, Synchronous read supported (1=yes) Bit 9 reserved
(P+6)h	3Fh	0	1h	
(P+7)h	40h	00	Oh	Synchronous read supported
(P+8)h	41h	00	Oh	
(P+9)h	42h	01h		Function allowed after Suspend: Program allowed after Erase Suspend (1=yes) Bit 7-1 reserved for future use
(P+A)h-(P+40)h	43h-7Fh			Reserved
(P+41)h	80h	xxxx xxxxh		Unique Device ID - 1 (16 bits)
(P+42)h	81h	xxxx xxxxh		Unique Device ID - 2 (16 bits)
(P+43)h	82h	XXXX	xxxxh	Unique Device ID - 3 (16 bits)
(P+44)h	83h	xxxx	xxxxh	Unique Device ID - 4 (16 bits)

Revision history

Table 33. Document revision history

Date	Revision	Changes
09-Jun-2006	1	Initial release.
23-Nov-2006	2	V _{PEN} signal renamed as PEN and <i>Program/Erase Enable (PEN)</i> modified. Continuous burst and wrap options are not available, X-Latencies 7 and 8 removed (see <i>Table 8: Burst Configuration Register</i> and <i>Table 9: Burst type definition</i>). Notes removed below <i>Table 8</i> . t _{WHQV} timing modified in <i>Table 20: Asynchronous Write and Latch controlled Write AC characteristics</i> . I _{DD} max modified and I _{DD4} added to <i>Table 17: DC characteristics</i> . t _{AXQX} modified in <i>Table 19: Asynchronous Page Read AC characteristics</i> . Read access specified in <i>Asynchronous Bus Read</i> and <i>Synchronous Burst Read</i> . t _{AVKH} and t _{ALKH} added and t _{KHQV} for 55 ns modified in <i>Table 21: Synchronous Burst Read AC characteristics. Figure 9, Figure 10, Figure 18</i> and <i>Figure 19</i> added. Double Word Program max modified and Minimum effective erase time added to <i>Table 12: Program, Erase times and endurance cycles</i> . All Asynchronous Bus Read AC characteristics brought together in <i>Table 18: Asynchronous Bus Read AC characteristics</i> . t _{LLEL} removed from <i>Table 18</i> and <i>Figure 7. Appendix B: Common Flash Interface (CFI)</i> modified.

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